

Industrial PROFET™

ITS6035S-EP-K 35 $m\Omega$ single channel smart high-side power switch



1 Overview



Features

- Single channel smart high-side power switch with integrated protection and diagnosis
- Maximum $R_{DS(ON)}$ 35 m Ω at T_i = 25°C
- Overvoltage lockout
- Supply voltage tolerance up to 60 V
- User adjustable current limitation ranging from: 3 A to 13.2 A
- Wide output current range
- Analog current sense pin
- Open load diagnosis
- Synchronized discharge functionality
- 24 V control inputs compatible to 3.3 V and 5 V logic levels
- 4 kV electrostatic discharge protection (ESD)
- Optimized electromagnetic compatibility
- Very small, thermally enhanced TSDSO-14 package
- Product validation according to JEDEC standard "JESD47J"
- Green product (RoHS compliant)

Potential applications

- Digital output modules (PLC applications, factory automation)
- Industrial peripheral switches and power distribution
- Switching resistive, inductive and capacitive loads in industrial environments
- Replacement for electromechanical relays, fuses and discrete circuits
- Most suitable for loads that require a flexible but precise current limit

Product validation

Qualified for industrial applications according to the relevant tests of JEDEC JESD47J.

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35 m Ω single channel smart high-side power switch



Overview

Description

The ITS6035S-EP-K is a single channel smart high side switch providing diagnosis capabilities and enhanced protection functions. The device offers an adjustable current limitation to offer higher reliability for protecting the system. It provides enhanced diagnostic features including an analog current sense pin and a separated status pin for sensing fault conditions. The ITS6035S-EP-K is designed to switch resistive, inductive or capacitive loads in the industrial application. The high voltage IN and DEN pins, can be directly be interfaced with an optocoupler.

Diagnostic functions

- Short circuit to ground (overload) indication
- Proportional load current sense information during ON-state under nominal load condition and fault current during overload condition (analog sense current and digital fault current are provided on IS-pin if DEN = high)
- · Open load detection in OFF
- Overtemperature switch off indication
- · Overvoltage lockout indication
- Stable diagnostic signal during short circuit, overtemperature shutdown and overvoltage lockout

Protection Functions

- Overvoltage protection and overvoltage lockout (switch off)
- User adjustable overload- and short circuit protection
- Stable behavior during undervoltage
- Overtemperature protection with restart after cooling down phase
- · Reverse polarity / inverse current protection with external components
- · Loss of ground protection

The qualification of this product is based on JEDEC JESD47J and may reference to existing qualification results of similar products. Such referring is justified by the structural similarity of the products. The product is not qualified and manufactured according to the requirements of Infineon Technologies with regard to automotive and/or transportation applications. Infineon Technologies administrates a comprehensive quality management system according to the latest version of the ISO9001 and IATF 16949.

The most updated certificates of the ISO9001 and IATF 16949 are available at www.infineon.com/cms/en/product/technology/quality/

Туре	Package	Marking
ITS6035S-EP-K	PG-TSDSO-14	IT6035SK

$35\ m\Omega$ single channel smart high-side power switch



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Block diagram

2 Block diagram

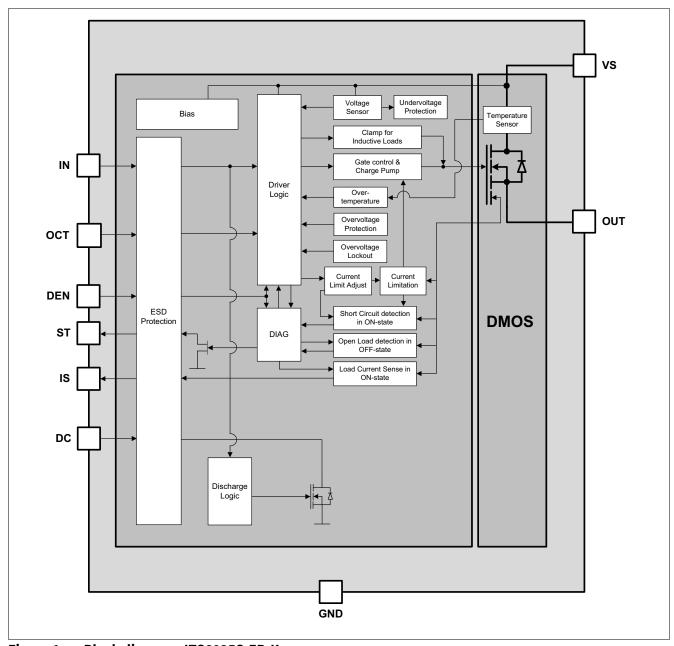


Figure 1 Block diagram: ITS6035S-EP-K



Pin configuration

3 Pin configuration

3.1 Pin assignment ITS6035S-EP-K (PG-TSDSO-14)

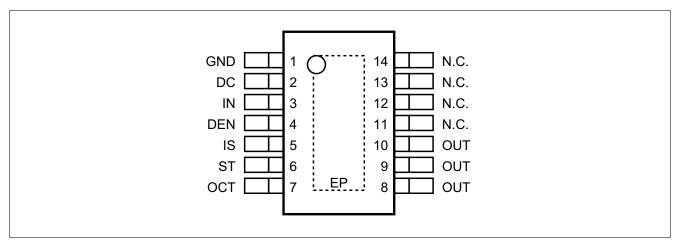


Figure 2 Pin configuration PG-TSDSO-14

3.2 Pin definitions and functions ITS6035S-EP-K (PG-TSDSO-14)

Symbol	Function
GND	Ground pin
DC	Discharge pin ; this pin provides a transient discharge path to device GND after switching the channel off ¹⁾
IN	Input Channel Control; digital input signal for channel activation, active high
DEN	Diagnosis Enable; digital input signal to enable/disable the extended diagnosis features analog current sense (during ON-state) and digital open load diagnosis (during OFF-state), active high
IS	Current Sense pin; provides accurate current sense information in ON-state when in nominal load condition. The current sense functionality is only active when enabled by the DEN-pin. The IS-pin must be connected with the sense resistor R_{SENSE} to ground.
ST	Status pin; open drain output to provide digital diagnosis information. Connect ST-pin with external pull-up resistor to high (logic level or V_s).
ОСТ	Over Current Threshold; connect pin with an appropriate external resistor to device GND in order to adjust the current limitation threshold to the desired value
OUT	Output; Protected high side power output channel ²⁾
N.C.	Not Connected
VS	Voltage Supply
	GND DC IN DEN IS ST OCT OUT N.C.

¹⁾ If this pin is not used it must be either left open or tied with a serial resistor to ground. Recommended value is $2.2 \text{ k}\Omega$

²⁾ All three output pins should be connected to each other on the PCB as close as possible to the corresponding pads in order to avoid non-homogeneous current densities on separated traces



Pin configuration

3.3 Voltage and current definitions

Figure 3 shows all terms used in this data sheet, with associated convention for positive values.

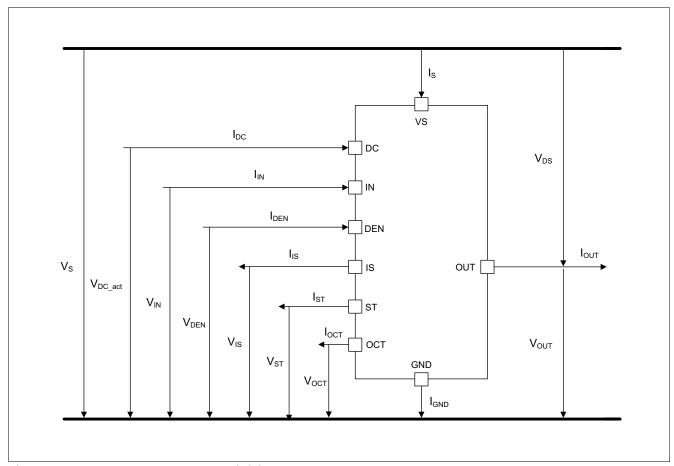


Figure 3 Voltage and current definitions

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General product characteristics

General product characteristics 4

Absolute maximum ratings 4.1

Absolute maximum ratings 1) Table 1

 $T_i = -40$ °C to 150°C, positive current flowing into pin; (unless otherwise specified)

Parameter	Symbol		Value	S	Unit	Note or Test Condition	Number	
		Min.	Тур.	Max.				
Supply voltages								
Supply voltage	V_{S}	-0.3	-	62	V	²⁾ t < 2 minutes	P_4.1.1	
Supply voltage	V _S	-0.3	_	60	V	Qualified for reduced mission profile of up to 125 h over lifetime	P_4.1.2	
Reverse polarity voltage	-V _{S(REV)}	0	-	28	V	t < 2 minutes; $T_A = 25^{\circ}\text{C}$; $R_L \ge 25 \Omega$; a sufficiently dimensioned ground path protection D_{GND} needs to be foreseen externally	P_4.1.3	
Supply voltage for short circuit protection	$V_{S(SC)}$	0	_	36	V	-	P_4.1.4	
Control input pins (IN, DEN)					1		1	
Voltage at control input pins	$V_{\rm IN}, V_{\rm DEN}$	-0.3	-	V_{S}	V	$V_{\rm S} \ge V_{\rm IN}; V_{\rm S} \ge V_{\rm DEN}$	P_4.1.5	
Current through control input pins	I _{IN} , I _{DEN}	-2	_	2	mA	-	P_4.1.6	
OCT-pin								
Voltage at OCT-pin	V_{OCT}	-0.3	-	V_{S}	V	$V_{\rm S} \ge V_{\rm OCT}$	P_4.1.7	
Current through OCT-pin	I _{OCT}	-2	-	2	mA	-	P_4.1.8	
DC-pin	•		•				•	
Voltage at DC-pin	$V_{ m DC_inact}$	-0.3	-	V_{S}	V	$V_{\rm S} \ge V_{\rm DC_inact}; I_{\rm DC} = 0$	P_4.1.9	
Voltage at DC-pin (discharge active)	V _{DC_act}	-	_	20	V	$V_{\rm S} > V_{\rm DC_act}; I_{\rm DC} \le I_{\rm DC_sink}$	P_4.1.28	
Current through DC-pin	I _{DC}	-250	-	250	mA	t < 2 minutes	P_4.1.10	
ST-pin	,	·	•				'	
Voltage at ST-pin	$V_{\rm ST}$	-0.3	_	V_{S}	V	$V_{\rm S} \ge V_{\rm ST}$	P_4.1.12	
Current through ST-pin	I _{ST}	-2	-	2	mA	-	P_4.1.13	
IS-pin	1			•				
Voltage at IS-pins	V _{IS}	-0.3	-	V_{S}	V	$V_{\rm S} \ge V_{\rm IS}$	P_4.1.14	
Current through IS-pin	I _{IS}	-35	-	35	mA	_	P_4.1.15	

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General product characteristics

Table 1 Absolute maximum ratings 1) (cont'd)

 $T_i = -40$ °C to 150°C, positive current flowing into pin; (unless otherwise specified)

Parameter	Symbol	bol Values Unit Min. Typ. Max.		S	Unit	Note or Test Condition	Number
Power stage		ı.		II.	11		
Power dissipation (DC)	P _{TOT}	-	_	2	W	$T_{A} = 85^{\circ}\text{C}$ $T_{J} < 150^{\circ}\text{C}$	P_4.1.16
Maximum energy dissipation Single pulse	E _{AS}	-	_	350	mJ	$I_L = 2 \text{ A}$ $T_j = 150^{\circ}\text{C}$ $V_S = 28 \text{ V}$	P_4.1.17
Voltage at power transistor	V_{DS}	_	-	65	V	-	P_4.1.19
Ground current							
Current through ground pin	I _{GND}	-20	_	20	mA	_	P_4.1.20
Temporary current through ground pin	I _{GND}	-250	-	250	mA	⁵⁾ <i>t</i> < 2 minutes	P_4.1.21
Temperatures		ı.		II.	11		
Junction temperature	$T_{\rm j}$	-40	_	150	°C	-	P_4.1.22
Storage temperature	T_{STG}	-55	_	150	°C	-	P_4.1.23
ESD susceptibility	1				1		•
ESD susceptibility (all pins)	V _{ESD_HBM}	-2	_	2	kV	⁶⁾ HBM	P_4.1.24
ESD susceptibility OUT-pin vs. GND and VS connected	V _{ESD_HBM}	-4	-	4	kV	⁶⁾ HBM	P_4.1.25
ESD susceptibility	V _{ESD_CDM}	-500	-	500	V	⁷⁾ CDM	P_4.1.26
ESD susceptibility pin (corner pins)	V _{ESD_CDM}	-750	_	750	V	⁷⁾ CDM	P_4.1.27

- 1) Not subject to production test; specified by design
- 2) Please note that in case of transient voltage spikes exceeding $V_{S(AZ)}$ the resulting GND current must be limited by an external resistor in the ground path in order to ensure I_{GND} remains inside the allowed maximum ratings
- Reverse polarity protection can only be achieved in combination with external components. For more details please
 refer to the corresponding chapters "Overvoltage protection" on Page 30 and "Reverse polarity protection" on
 Page 32.
- 4) This parameter serves as reference for the thermal budget: it illustrates the power dissipation that can be handled by the device in an application under the given boundary conditions before exceeding the maximum rating of T_j when assuming a R_{thJA} value for a thermally well dimensioned PCB connection like given in the JEDEC case $R_{thJA_2s2pvia}$ listed in **Table 3** in **Chapter 4.3**. As R_{thJA} depends strongly on the applied PCB and layout of any individual application the actual achievable values of P_{TOT} can either be lower or higher depending on the given application
- 5) During Discharge pin operation or during reverse current situations
- 6) ESD susceptibility, HBM according to ANSI/ESDA/JEDEC JS-001(1.5 k Ω , 100 pF)
- 7) ESD susceptibility, Charged Device Model "CDM" JEDEC JESD22-C101

Notes

- 1. Stresses above the ones listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.
- 2. Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.

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General product characteristics

4.2 **Functional range**

Table 2 **Functional range**

 T_i = -40°C to 150°C; (unless otherwise specified)

Parameter	Symbol		Value	5	Unit	Note or	Number
		Min.	Тур.	Max.		Test Condition	
Nominal operating voltage	$V_{S(NOM)}$	8	24	36	V	$V_{\rm S} \ge V_{\rm IN}; V_{\rm S} \ge V_{\rm DEN}$	P_4.2.1
Extended operating voltage	V _{S(NOM)}	5	-	V _{S(OV)_LO}	V	1) 2) $V_{S} \ge V_{IN}; V_{S} \ge V_{DEN}$	P_4.2.2
Overvoltage tolerance range (device is in OVLO standby mode)	$V_{\rm S(OV_TR)}$	$V_{S(OV)_RS}$	_	60	V	1) 3) $V_{S} \ge V_{IN}; V_{S} \ge V_{DEN}$	P_4.2.3
Minimum functional supply voltage during power-up	V _{S(OP)_MIN}	_	4.3	5	V	$V_{\rm S}$ increasing IN = high From $V_{\rm DS} = V_{\rm S}$ to $V_{\rm DS} \le 0.5$ V	P_4.2.4
Undervoltage shutdown	V _{S(UV)}	3	3.5	4.1	V	$V_{\rm S}$ decreasing IN = high From $V_{\rm DS} \le 1$ V to $V_{\rm DS} = V_{\rm S}$	P_4.2.5
Undervoltage shutdown hysteresis	$V_{\rm S(UV)_HYS}$	_	850	_	mV	1) _	P_4.2.6
Overvoltage lockout threshold ⁴⁾ (channel switch off/channel blocked from being switched on)	V _{S(OV)_LO}	47	51	55	V	$V_{\rm S} \ge V_{\rm IN}; V_{\rm S} \ge V_{\rm DEN}$ $V_{\rm S}$ rising	P_4.2.7
Overvoltage lockout restart voltage	V _{S(OV)_RS}	46	50	54	V	$V_{\rm S} \ge V_{\rm IN}; V_{\rm S} \ge V_{\rm DEN}$ $V_{\rm S}$ falling	P_4.2.8
Overvoltage lockout blanking time	t _{OV_BLK}	_	230	_	μs	1) 5) _	P_4.2.9
Overvoltage lockout hysteresis	$V_{\rm S(OV)_HYS}$	_	1	_	V	1) _	P_4.2.10
Junction temperature	T _j	-40	-	150	°C	_	P_4.2.11

- 1) Not subject to production test; specified by design
- 2) Parameter deviations are possible
- 3) Reduced mission profile applies
- 4) The overvoltage lockout state will be entered if this threshold is exceeded for longer than the blanking time $t_{\text{OV BLK}}$: in ON-state the channel will be switched off; when in OFF-state the channel will be blocked from being switched on until the OVLO event has cleared. In both cases a diagnosis fault is flagged at the ST-pin
- 5) This parameter applies for both cases OVLO standby mode being entered from OFF-state as well as from ON-state

Note:

Within the functional range the IC operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the related electrical characteristics table.

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General product characteristics

4.3 Thermal resistance

Table 3 Thermal resistance 1)

Parameter	Symbol	Values			Unit	Note or	Number	
		Min.	Min. Typ. Max.			Test Condition		
Junction to exposed pad soldering point	R _{thJC}	_	2	_	K/W	_	P_4.3.1	
Junction to ambient All channels active	R _{thJA_2s2pvia}	_	36	_	K/W	2) _	P_4.3.2	
Junction to ambient All channels active	R _{thJA_1s0p}	_	124	-	K/W	3) _	P_4.3.3	
Junction to ambient All channels active	R _{thJA_1s0p_300mm}	-	58	-	K/W	4) _	P_4.3.4	
Junction to ambient All channels active	R _{thJA_1s0p_600mm}	_	47	-	K/W	5) _	P_4.3.5	

- 1) Not subject to production test; specified by design
- 2) Specified R_{thJA} value is according to JEDEC JESD51-2,-5,-7 at natural convection on FR4 2s2p board; the product (chip + package) was simulated on a 76.2 × 114.3 × 1.5 mm board with 2 inner copper layers (2 × 70 μ m Cu, 2 × 35 μ m Cu). Where applicable a thermal via array under the exposed pad contacted the first inner copper layer
- 3) Specified R_{thJA} value is according to JEDEC JESD51-3 at natural convection on FR4 1s0p board, footprint; The product (chip + package) was simulated on a 76.2 × 114.3 × 1.5 mm board with 1 × 70 μ m Cu
- 4) Specified R_{thJA} value is according to JEDEC JESD51-3 at natural convection on FR4 1s0p board, 300 mm; The product (chip + package) was simulated on a 76.2 × 114.3 × 1.5 mm board with 1 × 70 μ m Cu
- 5) Specified R_{thJA} value is according to JEDEC JESD51-3 at natural convection on FR4 1s0p board, 600 mm; The product (chip + package) was simulated on a 76.2 × 114.3 × 1.5 mm board with 1 × 70 μ m Cu

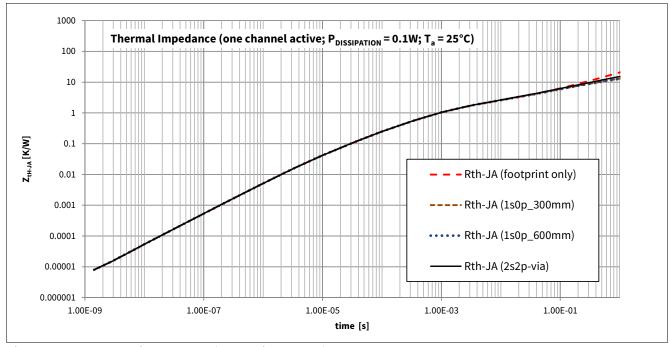
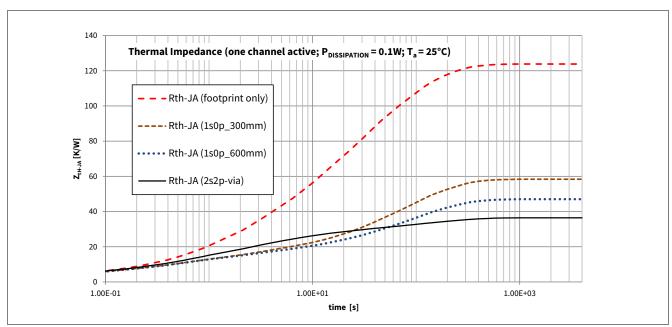


Figure 4 Thermal impedance (short time scale)

$35\ m\Omega$ single channel smart high-side power switch



General product characteristics



Thermal impedance (long time scale; one channel active) Figure 5



Operation and diagnostic modes

5 Operation and diagnostic modes

5.1 State diagram

Depending on supply voltage V_S , input signals and usage of diagnosis the ITS6035S-EP-K can be in different operation modes. **Figure 6** provides an overview of the operation modes and their corresponding operation currents.

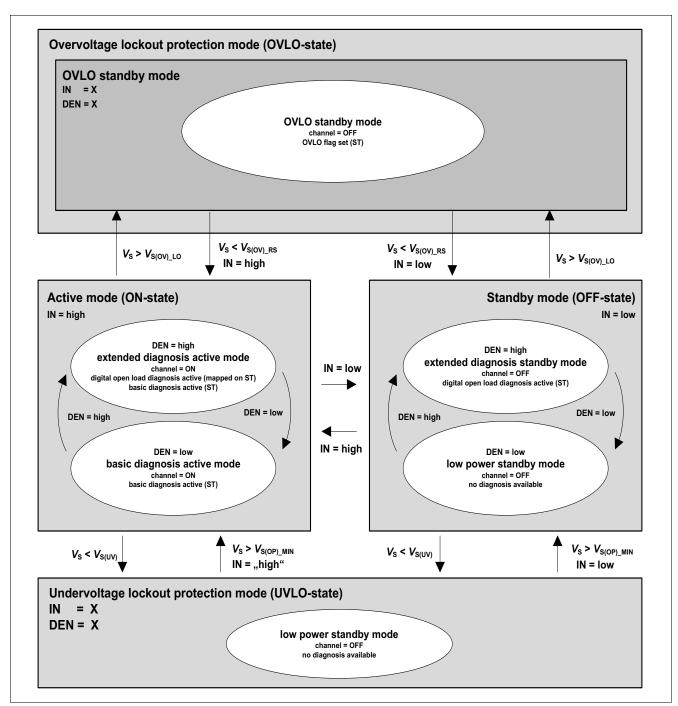


Figure 6 State diagram ITS6035S-EP-K

$35\ m\Omega$ single channel smart high-side power switch



Operation and diagnostic modes

Electrical characteristics: current consumption 5.2

Electrical characteristics: current consumption Table 4

 $V_{\rm S}$ = 8 V to 36 V, $T_{\rm i}$ = -40°C to 150°C (unless otherwise specified) Typical values are given at $V_S = 24 \text{ V}$, $T_j = 25 ^{\circ}\text{C}$

Parameter	Symbol		Value	S	Unit	Note or	Number
		Min.	Тур.	Max.		Test Condition	
Operation currents	1	<u>'</u>					1
ON - state current; DEN = L (basic diagnosis active mode)	$I_{\mathrm{GND_ON}}$	-	2.3	2.9	mA	1) $T_{j} \le 25^{\circ}\text{C};$ $V_{S} = 24 \text{ V};$ $V_{IN} = \text{high};$ $V_{DEN} = \text{low};$ $I_{OCT} = 50 \mu\text{A};$ $Device in R_{DS(ON)}$	P_5.2.6
ON - state current; DEN = L (basic diagnosis active mode)	I _{GND_ON}	-	2	2.5	mA	$T_{\rm j}$ = 150°C; $V_{\rm S}$ = 24 V; $V_{\rm IN}$ = high; $V_{\rm DEN}$ = low; $I_{\rm OCT}$ = 50 μA; Device in $R_{\rm DS(ON)}$	P_5.2.1
ON - state current; DEN = H (extended diagnosis active mode)	I _{GND_ON_ed}	-	2.6	3.2	mA	1) 2) $T_j \le 25$ °C; $V_S = 24$ V; $V_{IN} = \text{high};$ $V_{DEN} = \text{high};$ $I_{OCT} = 50 \mu\text{A};$ Device in $R_{DS(ON)}$	P_5.2.7
ON - state current; DEN = H (extended diagnosis active mode)	I _{GND_ON_ed}	-	2.3	2.8	mA	$T_{\rm j} = 150$ °C; $V_{\rm S} = 24$ V; $V_{\rm IN} = {\rm high};$ $V_{\rm DEN} = {\rm high};$ $V_{\rm OCT} = 50~{\rm \mu A};$ Device in $R_{\rm DS(ON)}$	P_5.2.2
Standby currents (to device	GND)						
OFF - state current; DEN = low (Low power standby mode)	I _{GND_OFF}	_	0.1	1	μΑ	$V_{\rm S} = 24 \text{V};$ $V_{\rm IN}$ floating; $V_{\rm DEN}$ floating	P_5.2.3
OFF - state current; DEN = high (extended diagnosis standby mode)	I _{GND_OFF_ed}	-	1.3	1.6	mA	$V_S = 24 \text{ V};$ $V_{IN} = 0 \text{ V};$ $V_{DEN} = \text{high}$	P_5.2.4

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Operation and diagnostic modes

Table 4 Electrical characteristics: current consumption (cont'd)

 V_S = 8 V to 36 V, T_j = -40°C to 150°C (unless otherwise specified) Typical values are given at V_S = 24 V, T_j = 25°C

Parameter	Symbol	Symbol Values				Note or	Number
		Min.	Тур.	Max.		Test Condition	
Overvoltage lockout mode o	urrent	*			*		
OVLO standby mode current (DEN = IN = X)	I _{GND_OVLO}	-	1.5	-	mA	$V_{S} = 60 \text{ V};$ $0 \text{ V} \leq V_{IN} \leq V_{S};$ $0 \text{ V} \leq V_{DEN} \leq V_{S}$	P_5.2.5

¹⁾ The current flowing out of the OCT-pin I_{OCT} depends on the adjusted current limitation value (R_{OCT}) and is not included in this parameter. In case of fault conditions also an additional current may be drawn from the ST-pin to device GND if applied. The ST-pin current - if applicable - is also not included in this parameter

- 2) Current flowing out of the current sense pin, IS is not included in this parameter. The sense current in normal operation is given by the fraction of I_{Load}/k_{ILIS} . During short circuit/overload fault conditions the related fault current will be flowing out of the IS-pin as long as the device is not entering thermal shutdown or the DEN-pin is pulled from high to low (mode change from "extended diagnosis active mode" to "basic diagnosis active mode")
- 3) The ST-pin current drawn by the ST-pin to device GND if applied is not included in this parameter. The ST-pin current during fault conditions will depend on the external pull-up circuit

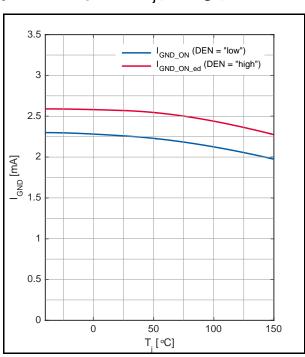


Operation and diagnostic modes

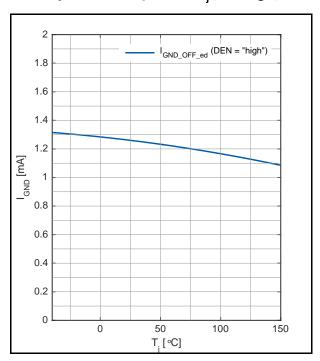
5.3 Typical performance characteristics current consumption

Typical performance characteristics

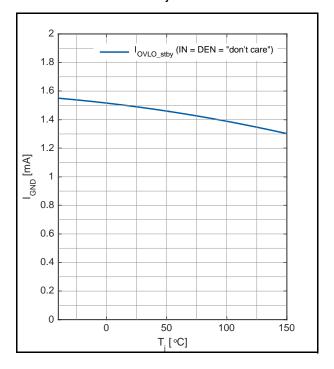
Operating current I_{GND_ON} versus junction temperature T_i (IN = high)



Extended diagnosis standby current $I_{GND_OFF_ed}$ versus junction temperature T_i (IN = high)



Overvoltage lockout mode current I_{OVL_stby} versus junction temperature T_i





6 Power stage

The power stage is built using an N-channel vertical power MOSFET (DMOS) with charge pump.

6.1 Output ON-state resistance

The ON-state resistance $R_{\rm DS(ON)}$ of the power stage depends on supply voltage as well as on junction temperature $T_{\rm j}$. Figure 7 shows the influence of temperature on the typical ON-state resistance. The behavior of the power stage in reverse polarity condition is described in **Chapter 7.4**.

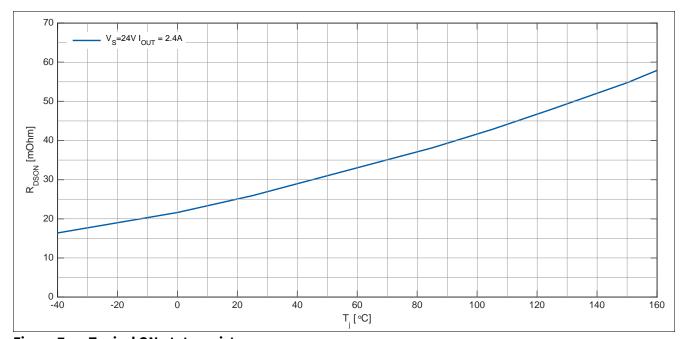


Figure 7 Typical ON-state resistance

6.2 Turn on/off characteristics with resistive load

A high signal at the input pin (see **Chapter 10**) causes the power DMOS to switch on with a dedicated slope, which is optimized in terms of EMC emission.

Figure 8 shows the typical timing when switching a resistive load.

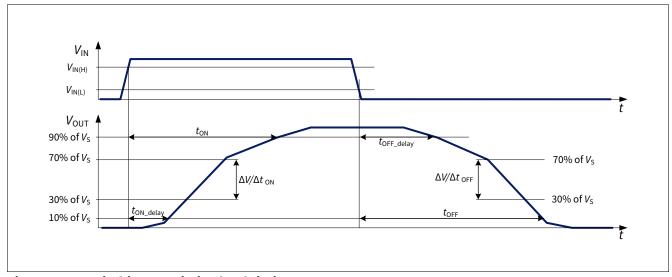


Figure 8 Switching a resistive load timing



6.3 Inductive load

6.3.1 Output clamping

When switching off inductive loads with high-side switches, the voltage V_{OUT} drops below ground potential, because the inductance intends to continue driving the current. To prevent the destruction of the device by avalanche due to high voltage drop over the power stage a voltage clamp mechanism $Z_{DS(AZ)}$ is implemented that limits negative output voltage to a certain level ($V_{\rm S}$ - $V_{\rm DS(AZ)}$). The clamping mechanism allows in addition a fast demagnetization of inductive loads because during the phase of active clamping the power is dissipated to a great extent rapidly inside the switch. On the other hand, the power dissipated inside the switch while switching off inductive loads can cause considerable stress to the device. Therefore the maximum allowed energy at a given current (and by this also the inductance) is limited. In Figure 9 and Figure 10 the basic principle of active clamping is illustrated as well as simplified waveforms when switching off inductive loads. If the DC-pin is utilized to discharge the output after switching off the channel a blocking diode has to be placed between DC-pin and OUT 1). This diode ensures a stable behavior of the output clamp with the DC-pin attached to OUT while switching off inductive loads. Without this diode current would flow from device GND via the DC path to the output OUT bypassing the output clamp structure and potentially overstress or destroy the DC-pin or the GND path. In addition a series resistor has to be placed in the DC path to limit the power dissipation inside the IC. For a more details on the usage of the DC-pin and required external components please refer to Chapter 8.

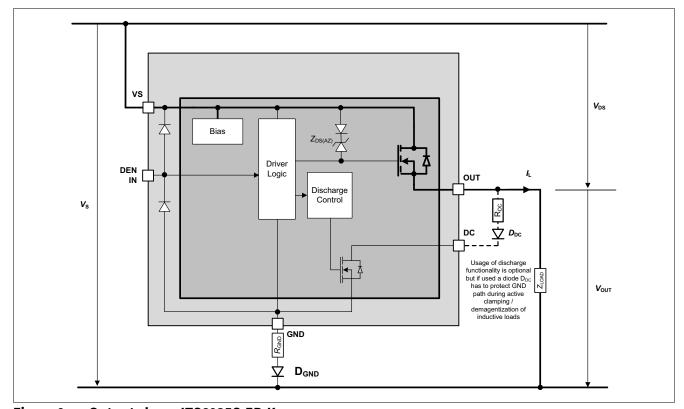


Figure 9 Output clamp ITS6035S-EP-K

¹⁾ In general, the usage of a blocking diode in the DC path is mandatory if the DC-pin is at risk of being pulled below device GND inside the application



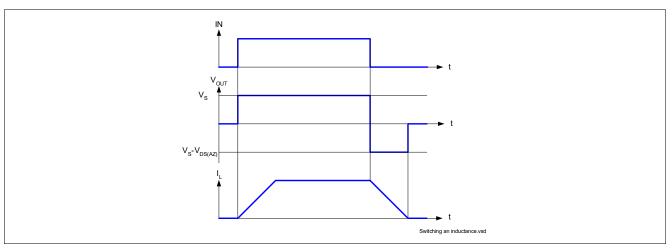


Figure 10 Switching an Inductive load timing

6.3.2 Maximum load inductance

During demagnetization of inductive loads, the following energy must be dissipated by the ITS6035S-EP-K. This energy can be calculated by help of the following equation:

$$E = V_{\mathrm{DS}(\mathrm{AZ})} \times \frac{L}{R_{\mathrm{L}}} \times \left[\frac{V_{\mathrm{S}} - V_{\mathrm{DS}(\mathrm{AZ})}}{R_{\mathrm{L}}} \times \ln\left(1 - \frac{R_{\mathrm{L}} \times I_{\mathrm{L}}}{V_{\mathrm{S}} - V_{\mathrm{DS}(\mathrm{AZ})}}\right) + I_{\mathrm{L}} \right]$$

$$\tag{6.1}$$

Following equation gets simplified under the assumption of $R_L = 0 \Omega$:

$$E = \frac{1}{2} \times L \times I^2 \times \left(1 - \frac{V_S}{V_S - V_{DS(AZ)}}\right)$$
(6.2)

The energy, which may be converted into heat, is limited by the thermal design of the component. See **Figure 11** for the maximum allowed energy dissipation as a function of the load current for a singular pulse event on the channel.

35 m Ω single channel smart high-side power switch



Power stage

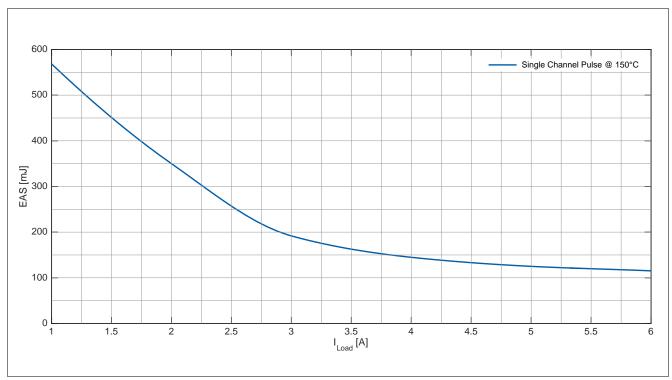


Figure 11 Maximum energy dissipation single pulse; $V_s = 28 \text{ V}$

6.4 **Inverse current capability**

In case of inverse current, meaning a voltage V_{INV} at the output higher than the supply voltage V_{S} , a current I_{INV} will flow from output to VS-pin via the body diode of the power transistor (please refer to Figure 12). If the channel is active (ON-state) by the time when the inverse current condition appears it will remain active and its output stage will follow the state of the corresponding IN-pin, which means that the channel can be switched off during inverse current condition. If the channel is inactive (OFF-state) by the time when the inverse current condition appears it will remain inactive regardless of the state of the IN-pin. If during an inverse current condition the IN-pin is set from low to high in order to activate the channel, the output stage of the channel is kept OFF until the inverse current disappears. For all cases the current I_{INV} should not be higher than $I_{L(INV)}$. Please note that during inverse current condition the protection functions are not available.



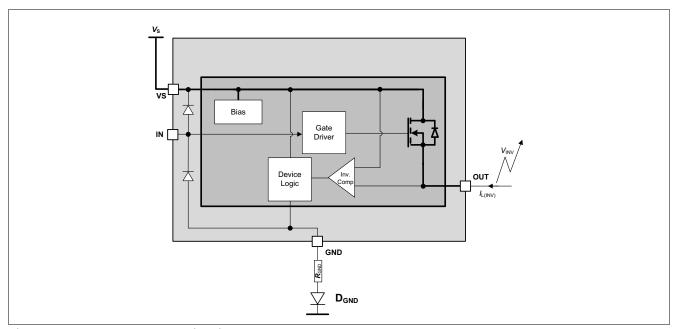


Figure 12 Inverse current circuitry ITS6035S-EP-K

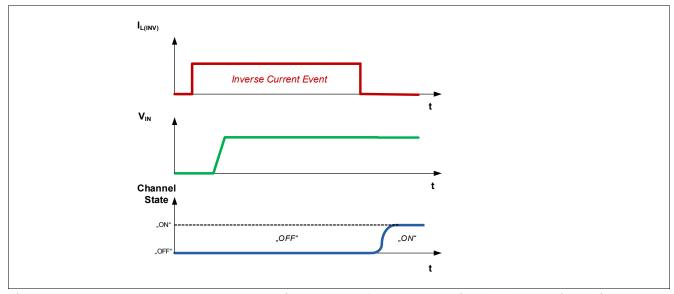
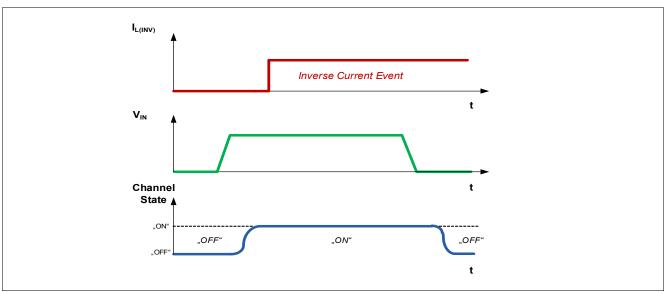


Figure 13 Inverse current event: channel in OFF-state (channel remains off for duration of inverse current event)





Inverse current event: channel in ON-state (output not influenced and can be switched off) Figure 14

Electrical characteristics: Power stage 6.5

Table 5 **Electrical characteristics: Power stage**

 $V_{\rm S}$ = 8 V to 36 V, $T_{\rm j}$ = -40°C to 150°C (unless otherwise specified) Typical values are given at $V_S = 24 \text{ V}$, $T_i = 25 ^{\circ}\text{C}$

Parameter	Symbol		Value	S	Unit	Note or	Number
		Min.	Тур.	Max.		Test Condition	
ON-state resistance $(T_j = 25^{\circ}C)$	R _{DS(ON)}	_	27	35	mΩ	$I_{L} = 2.0 \text{ A};$ $V_{IN} = \text{high};$ $T_{j} = 25^{\circ}\text{C}$	P_6.5.1
ON-state resistance $(T_j = 125^{\circ}C)$	R _{DS(ON)_125}	_	48	-	mΩ	$I_{L} = 2.0 \text{ A};$ $V_{IN} = \text{high};$ $T_{j} = 125^{\circ}\text{C}$	P_6.5.2
ON-state resistance $(T_j = 150^{\circ}C)$	R _{DS(ON)_150}	_	55	70	mΩ	I_L = 2.0 A; V_{IN} = high; T_j = 150°C	P_6.5.3
Allowable nominal load current range in conjunction with a selected current limit setting or based on thermal constraints	I _{L(NOM)}	_	5.0		A	1) 2) $T_A = 85^{\circ}\text{C},$ $T_J < 150^{\circ}\text{C}$	P_6.5.4
Output voltage drop limitation at small load currents	V _{DS(SLC)}	-	12	25	mV	I _L = 10 mA	P_6.5.20
Drain to source clamping voltage $V_{DS(AZ)} = [V_S - V_{OUT}]$	$V_{DS(AZ)}$	65	70	75	V	I _{DS} = 5 mA	P_6.5.6

$35\ m\Omega$ single channel smart high-side power switch



Power stage

Electrical characteristics: Power stage (cont'd) Table 5

 $V_{\rm S}$ = 8 V to 36 V, $T_{\rm j}$ = -40°C to 150°C (unless otherwise specified) Typical values are given at $V_S = 24 \text{ V}$, $T_j = 25 ^{\circ}\text{C}$

Parameter	Symbol		Value	S	Unit	nit Note or Test Condition	Number
		Min.	Тур.	Max.			
Output leakage current (OFF-state)	I _{L(OFF)}	-	0.1	0.5	μΑ	$V_{IN} = low;$ $V_{OUT} = 0 V;$ $T_j \le 85^{\circ}C$	P_6.5.7
Output leakage current (OFF-state)	I _{L(OFF)_150}	_	2.5	5	μΑ	$V_{IN} = low;$ $V_{OUT} = 0 V;$ $T_j = 150$ °C	P_6.5.8
Output leakage current in overvoltage lockout (OVLO-state)	I _{L(OVLO)}	_	5.5	18	μА	1) 3) $V_{S} = 60 \text{ V};$ $V_{IN} = V_{DEN} = \text{"X"};$ $V_{OUT} = 0 \text{ V};$ $T_{j} \le 25^{\circ}\text{C}$	P_6.5.21
Output leakage current in overvoltage lockout (OVLO-state)	I _{L(OVLO)_150}	_	4	6.9	μΑ	3) $V_{S} = 60 \text{ V};$ $V_{IN} = V_{DEN} = \text{"X"};$ $V_{OUT} = 0 \text{ V};$ $T_{j} = 150 \text{°C}$	P_6.5.22
Inverse current capability	I _{L(INV)}	_	2.2	-	A	1) 4) $V_{\rm S} < V_{\rm OUT};$ $t < 2$ minutes	P_6.5.9
Slew rate (switch on) 30% to 70% of V _S	$\Delta V/\Delta t_{ m ON}$	-	0.7	-	V/µs	$R_{L} = 12 \Omega;$ $V_{S} = 24 V;$ $I_{OCT} = 50 \mu A$	P_6.5.10
Slew rate (switch off) 70% to 30% of V _S	$-\Delta V/\Delta t_{OFF}$	-	0.7	-	V/µs	$R_L = 12 \Omega;$ $V_S = 24 V;$ $I_{OCT} = 50 \mu A$	P_6.5.11
Turn on time to $V_{\text{OUT}} = 90\% \text{ of } V_{\text{S}}$	t _{ON}	_	60	85	μs	$R_L = 12 \Omega;$ $V_S = 24 V;$ $I_{OCT} = 50 \mu A;$ $V_{DEN} = low$	P_6.5.13
Turn off time to $V_{\text{OUT}} = 10\% \text{ of } V_{\text{S}}$	t _{OFF}	-	55	85	μs	$R_{L} = 12 \Omega;$ $V_{S} = 24 V;$ $I_{OCT} = 50 \mu A$	P_6.5.14
Turn on/off matching $t_{\rm OFF}$ - $t_{\rm ON}$	$\Delta t_{\sf SW}$	-35	0	35	μs	$R_L = 12 \Omega;$ $V_S = 24 V;$ $I_{OCT} = 50 \mu A$	P_6.5.15

35 m Ω single channel smart high-side power switch



Power stage

Table 5 **Electrical characteristics: Power stage** (cont'd)

 $V_{\rm S}$ = 8 V to 36 V, $T_{\rm i}$ = -40°C to 150°C (unless otherwise specified) Typical values are given at $V_S = 24 \text{ V}$, $T_i = 25 ^{\circ}\text{C}$

Parameter	Symbol	Values			Unit	Note or	Number
		Min.	Тур.	Max.		Test Condition	
Turn on time to $V_{\text{OUT}} = 10\% \text{ of } V_{\text{S}}$	$t_{ m ON_delay}$	-	25	40	μѕ	$R_L = 12 \Omega;$ $V_S = 24 V;$ $I_{OCT} = 50 \mu A;$ $V_{DEN} = low$	P_6.5.16
Turn off time to $V_{\text{OUT}} = 90\% \text{ of } V_{\text{S}}$	t _{OFF_delay}	-	25	40	μs	$R_{L} = 12 \Omega;$ $V_{S} = 24 V;$ $I_{OCT} = 50 \mu A$	P_6.5.17

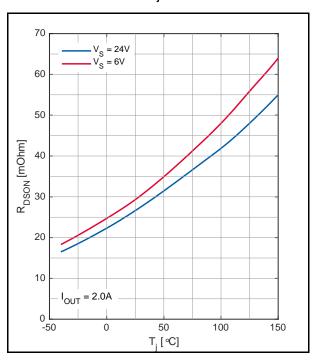
- 1) Not subject to production test; specified by design
- The allowable nominal load current can be restricted by two different factors the magnitude of the adjusted current limitation but as well by thermal constraints. The minimum limit given here corresponds to the limitation by the current limitation when adjusted to its minimum value ($I_{OCT} = 6.67 \mu A$) while the maximum limit corresponds to the thermal limitation where the maximum $T_{\rm i}$ of 150°C is reached assuming $T_{\rm AMB}$ =85°C and $R_{\rm thJA_2s2pvia}$. In normal operation the minimum required distance of $I_{L(NOM)}$ to the adjusted current limitation has to be maintained. For further details and numbers please refer to Table 14
- 3) Valid after output is completely switched off
- 4) Please note that during inverse current condition the protection features are not operational
- 5) This timing will be faster if device is in extended diagnosis standby mode (DEN = high). For further details see typical performance graphs "Turn on time ton to Vout = 90% versus current limit adjust current Ioct (DEN = low & high)" on Page 27 and "Turn on delay time t_{ON delay} to V_{OUT} = 10% versus current limit adjust current I_{OCT} (DEN = low & high)" on Page 27



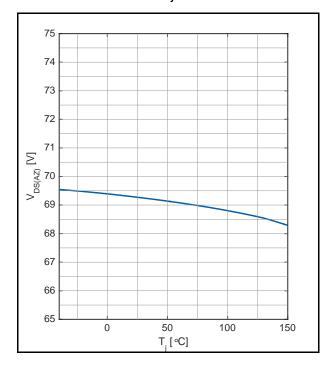
6.6 Typical performance characteristics power stage ITS6035S-EP-K

Typical performance characteristics

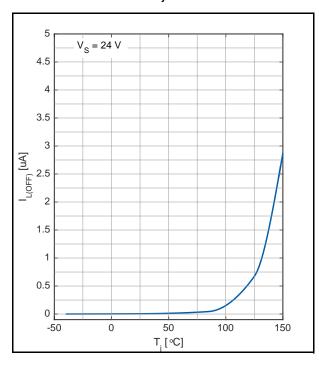
ON-state resistance $R_{\rm DSON}$ versus junction temperature $T_{\rm i}$



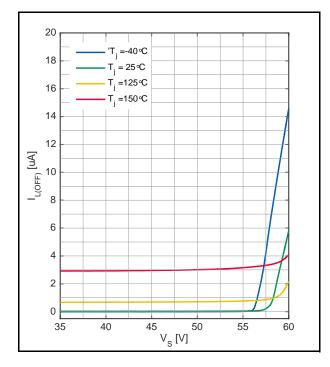
Output clamp voltage $V_{\rm DS(AZ)}$ versus junction temperature $T_{\rm i}$



Output leakage current $I_{L(OFF)}$ versus junction temperature T_i

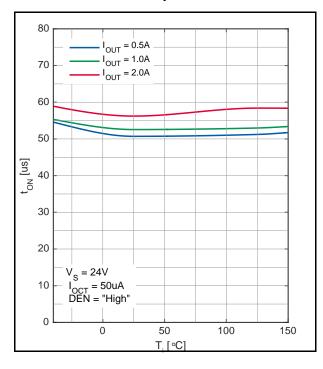


Output leakage current when entering OVLO versus supply voltage $V_{\rm S}$

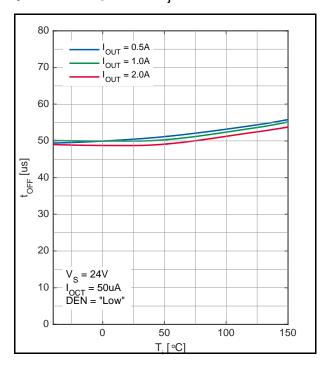




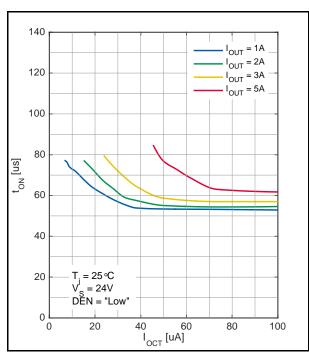
Turn on time t_{ON} to V_{OUT} = 90% versus junction temperature T_i



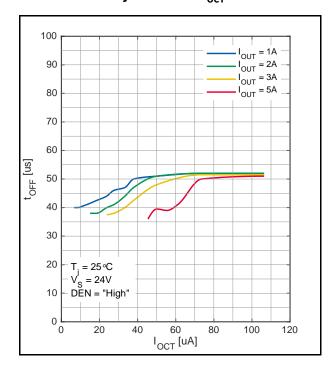
Turn off time t_{OFF} to V_{OUT} = 90% versus junction temperature T_i



Turn on time t_{ON} to V_{OUT} = 90% versus current limit adjust current I_{OCT}



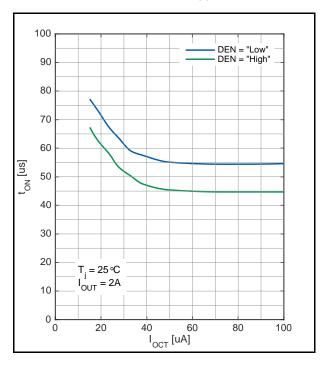
Turn off time t_{OFF} to $V_{\text{OUT}} = 10\%$ versus current limit adjust current I_{OCT}

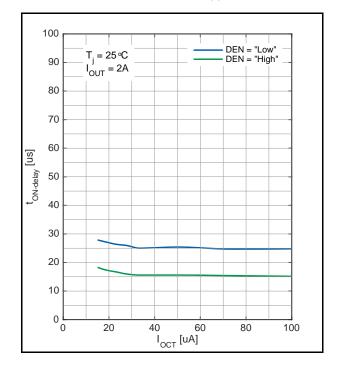


$35 \ m\Omega$ single channel smart high-side power switch



Power stage







Protection functions

7 Protection functions

The device provides integrated protection functions. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Protection functions are designed to prevent the destruction of the ITS6035S-EP-K due to fault conditions described in the data sheet. Please note that fault conditions are not considered as normal operation conditions and the protection functions are neither designed for continuous operation nor for repetitive operation.

7.1 Loss of ground protection

In case of loss of module ground when the load remains connected to ground, the device protects itself by automatically turning off (when it was previously on) or remaining off, regardless of the voltage applied at the input pin, IN.

In an application where the input IN is directly controlled by logic levels $< V_S$ (e.g. by a microcontroller without galvanic isolation), it is recommended to use input resistors ¹⁾ between the external control circuit (microcontroller) and the ITS6035S-EP-K to protect also the external control circuit in case of loss of ground.

In case of loss of module or device ground, a current $(I_{OUT(GND)})$ can flow out of the DMOS as is illustrated in **Figure 15**, below.

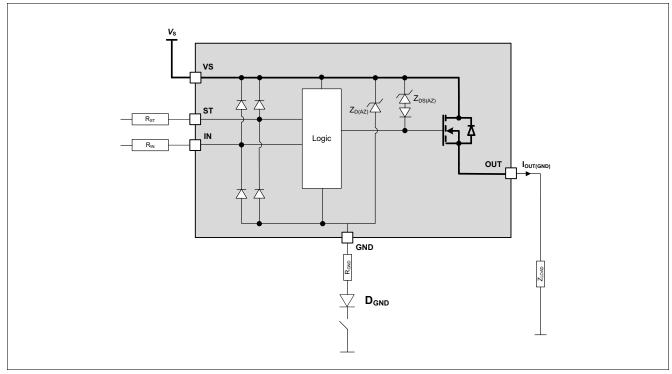


Figure 15 Loss of ground protection with external components



Protection functions

7.2 Undervoltage protection

If the supply voltage falls below $V_{S(UV)}$ the undervoltage protection of the device is triggered. $V_{S(UV)}$ represents hence the minimum voltage for which the switch still can hold ON. Once the device is off $V_{S(OP)_MIN}$ represents the lowest voltage where the device is turning on again (and thus the channel can be switched again). If the supply voltage is below the undervoltage threshold $V_{S(UV)}$, the channel of the device is off (or turning off). As soon as the supply voltage is recovering and exceeding the threshold of the functional supply voltage $V_{S(OP)_MIN}$, the device is re-powering and its channel can be switched again. In addition the protection functions as well as diagnosis becomes operational once $V_{S(OP)_MIN}$ is reached. **Figure 16** illustrates the undervoltage mechanism.

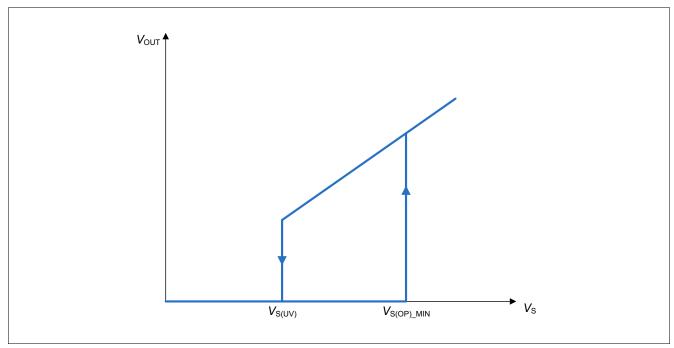


Figure 16 Undervoltage behavior

35 m Ω single channel smart high-side power switch



Protection functions

7.3 Overvoltage protection

The ITS6035S-EP-K provides an overvoltage protection. The overvoltage protection consists of two different sub-functions. First there is an overvoltage lockout mechanism (OVLO) to protect the load in case of permanent overvoltage on the V_S - line above the extended functional range up to a value of 60 V. In addition to the OVLO protection there is an integrated overvoltage clamp mechanism that protects the IC itself in case of short overvoltage pulses above $V_{S(AZ),MIN}$ that may occur on the V_S - line.

7.3.1 Overvoltage lockout

The overvoltage lockout (OVLO) of the ITS6035S-EP-K is defined in first place to protect the load in case of unwanted voltage excursions on the $V_{\rm S}$ - line that may occur and persist for longer times (from ms range up multiple days). An OVLO event will be recognized if $V_{\rm S}$ exceeds a threshold value of $V_{\rm S(OV)_LO,TYP}$ for a duration longer than the blanking time of $t_{\rm OVLO_BLK,TYP}$. If an OVLO event is recognized during active mode the channel will be immediately switched off regardless of the logic state of the IN-pin and remains locked out until the overvoltage situation has cleared. Overvoltage events exceeding the OVLO threshold but not lasting longer than the blanking time will be filtered out by the OVLO circuit in order to avoid unwanted shut-off events. The OVLO circuit has a hysteresis of $V_{\rm S(OV)_HYS,TYP}$ to ensure a stable behavior. The device will return to normal operation once $V_{\rm S}$ is falling back below the OVLO threshold and the built-in hysteresis. With other words the output channel will follow the state of the IN-pin again after $V_{\rm S}$ is in back in its functional range. If the ITS6035S-EP-K is facing an OVLO event a diagnosis flag will be set on the ST-pin for the duration of the OVLO event. Once the OVLO circuit has switched off the output channel the ITS6035S-EP-K will remain in OVLO standby mode for the duration of the overvoltage event where it just provides diagnosis information and keeps monitoring $V_{\rm S}$. The ITS6035S-EP-K is qualified to remain in the OVLO-state for macroscopic time scales of up to 125 hours over lifetime at $V_{\rm S,MAX}$.

The ITS6035S-EP-K is able to detect OVLO events not only during active mode but also when the device is in standby mode (both - low power standby mode and extended diagnosis standby mode) where the channel is already off. In order to be able to detect an OVLO event during OFF-state the ITS6035S-EP-K has a corresponding wake-up routine implemented. OVLO events during OFF-state will block the input pin circuitry for activation of the channel until the overvoltage situation is cleared while the ST-pin is flagging the OVLO fault situation regardless of the logic state of the DEN-pin. (For further details please refer to the corresponding truth table **Table 9** in **Chapter 9**).

35 m Ω single channel smart high-side power switch



Protection functions

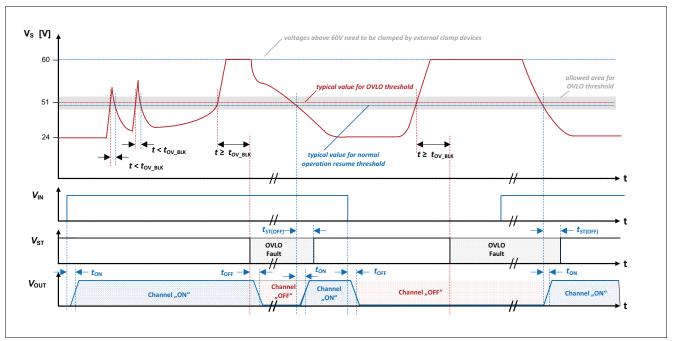


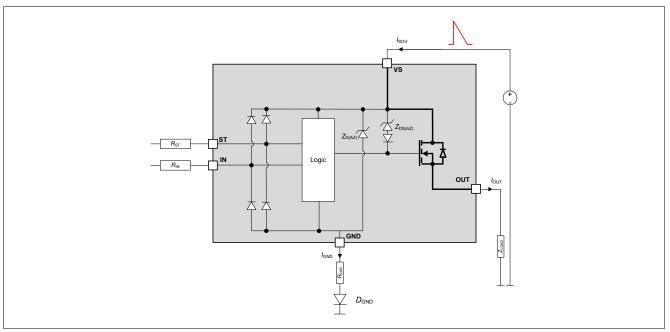
Figure 17 Exemplary overview of overvoltage lockout and overvoltage clamping

7.3.2 Overvoltage clamp

In addition to the OVLO feature there is an integrated clamping mechanism for overvoltage protection $(Z_{D(AZ)})$ against transient overvoltage spikes. To ensure this mechanism operates properly within the application, the current in the Zener diode $Z_{D(AZ)}$ must be limited by an external GND protection R_{GND} . **Figure 18** shows a typical application to withstand overvoltage events. In case of supply voltage transients higher than $V_{S(AZ)}$, the voltage from supply to device ground is clamped. As a result, the device ground potential rises to $V_S - V_{S(AZ)}$. Due to the ESD Zener diodes, the potential at pin IN rises almost to that potential, depending on the impedance of the connected circuitry. As a consequence, in case of transient overvoltage events $V_{S(AZ)}$, external resistors have to be placed at the control pins that limit the current that can flow out of these pins while the device GND potential becomes higher than the voltage level at the control pins. Next to these protection resistors at the control pins also the GND path itself has to be protected against excessive current flow during such pulses by placing a resistor in the GND path. For a more detailed description of external devices for protection under fault conditions please refer to **Chapter 11.2**.



Protection functions

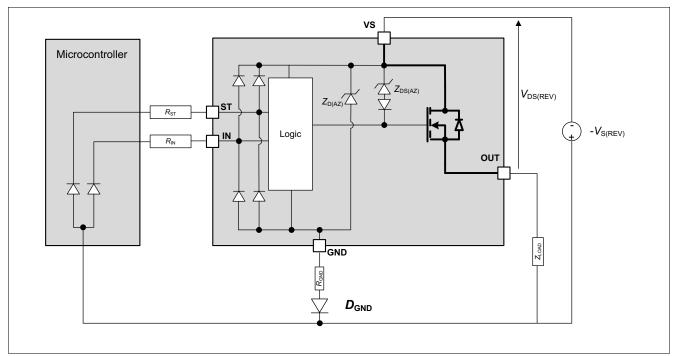


Overvoltage clamp protection with external components Figure 18

7.4 **Reverse polarity protection**

In case of reverse polarity, the intrinsic body diodes of the power DMOS will dissipate power. The current flowing through the intrinsic body diode is limited externally by the load itself. But in addition also the current into the ground path and the logic pins must be limited by external components to the maximum allowed current described in Chapter 4.1. Figure 19 shows a typical application. As external protection of the ground path the usage of a diode in the GND-path is recommended. For a more detailed description of external devices for protection please refer to Chapter 11.2

During reverse polarity no protection functions are available.



Reverse polarity protection with external components

35 m Ω single channel smart high-side power switch



Protection functions

7.5 Overload protection

In case of overload, such as high inrush currents or short circuit to ground, the ITS6035S-EP-K offers a set of protection mechanisms. It comprises an accurate current limitation as a first step and in addition a very effective temperature limitation in case of overtemperature caused by being in current limitation mode for longer periods or other root causes for overtemperature.

7.5.1 Current limitation

The ITS6035S-EP-K provides a very versatile and user friendly current limitation functionality that can be adjusted externally by the user in a broad range. The adjustment of the current limitation threshold $I_{\text{LIM}(\text{th},\text{adj})}$ to the desired value is controlled by the I_{OCT} current that is driven by the overcurrent threshold pin (OCT-pin) out of the device. The OCT-pin thereby is acting as a voltage source providing V_{OCT} . In the most simple and straight forward way the current limit adjustment can hence be achieved by connecting the OCT-pin with an appropriately dimensioned resistor to device ground. **Figure 21** is illustrating the usage of the adjustable current limitation. Please note that the values for the current limitation threshold $I_{\text{LIM}(\text{th},\text{adj})}$ are defined in such a way that they coincide with the typical values of the resulting current limitation at 25°C. The typical values of the current limitation at different temperatures may hence differ from $I_{\text{LIM}(\text{th},\text{adj})}$ to a certain degree. Typical values of the current limitation for different temperatures as a function of I_{OCT} are shown in **Figure 20**.

The adjusted current limit threshold $I_{LIM(th,adj)}$ is a function of the current I_{OCT} driven by the OCT-pin.

The appropriate resistor, R_{OCT} can be derived by the equation ¹⁾:

$$R_{OCT} = (V_{OCT})/(I_{OCT})$$
(7.1)

The specified range of $I_{\rm OCT}$ that can be used to adjust $I_{\rm LIM(th,adj)}$ allows to vary the current limitation over a wide area. If the upper specified $I_{\rm OCT}$ range is exceeded resulting in higher $I_{\rm OCT}$ currents the current limitation will not change anymore and saturates at its maximum current limit $I_{\rm LIM_int(MAX)}$. This means that from this point onwards any further increase of $I_{\rm OCT}$ will not result in increased current limitation values anymore. This is useful in case the OCT-pin unintentionally is shorted to GND to provide also in this case a basic protection for the device and the application. Despite this additional protection feature the device must not be operated with $I_{\rm OCT}$ currents above the allowed range as the $R_{\rm OCT}$ resistor also has additional functions. On the one hand $R_{\rm OCT}$ has always to be in place to protect the pin in case of reverse polarity situations while on the other hand $R_{\rm OCT}$ will also reduce potential EMC disturbances at the OCT-pin 2 . If $I_{\rm OCT}$ exceeds the threshold $I_{\rm OCT(short2GND)}$ it will be reported as a fault flag on the ST-pin. Please note that this fault flag will be set only during ON-state when DEN = low. For more details about diagnosis upon being outside the specified $I_{\rm OCT}$ range please refer to Chapter 9.1.

 R_{OCT} values causing the I_{OCT} currents below the specified OCT adjust range are not recommended for usage as the resulting current limitation suffers from limited accuracy and hence is not specified.

The adjustable current limitation feature of the ITS6035S-EP-K offers several advantages and flexibility to the user. When adjusting the device to a specific current limitation threshold LIM(th,adj), ensure that between the adjusted current limitation threshold $I_{\text{LIM}(\text{th},\text{adj})}$ and the expected nominal current of the application there is a certain distance in order to avoid unwanted activation of the current limitation circuit during normal operation. **Table 13** defines the maximum allowable load current for a certain OCT resistor setting.

Please note that when the load current of the device gets close(r) to the adjusted current limitation threshold, the turn on slew rate gets slower, resulting in longer $t_{\rm ON}$ timing, while at the same time corresponding turn off slew rate may become faster leading to shorter $t_{\rm OFF}$ timings.

¹⁾ A look-up table with values can be found in Chapter 11.3

²⁾ For this reason R_{OCT} should always be placed as close as possible to the OCT-pin



Protection functions

Keeping the above mentioned distance will ensure that the influence of the current limitation threshold on switching timings is moderate and is illustrated in the graph "Turn on time t_{ON} to V_{OUT} = 90% versus current limit adjust current I_{OCT} (DEN = low & high)" on Page 27.

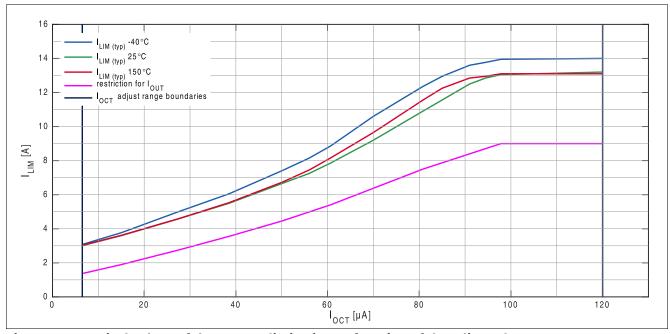


Figure 20 Typical values of the current limitation as function of the adjusted I_{OCT} current

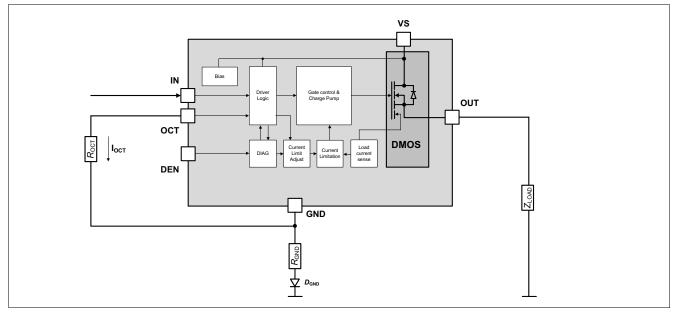


Figure 21 Adjustment of Current Limit threshold with external resistor R_{OCT}



Protection functions

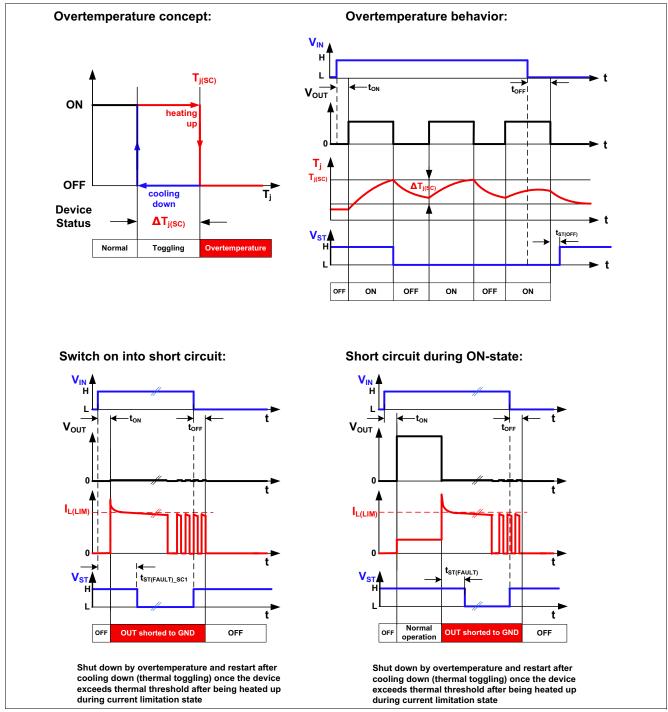


Figure 22 Protection behavior of the ITS6035S-EP-K

7.5.2 Temperature limitation in the power DMOS

The DMOS channel incorporates a temperature sensor concept that allows to detect the absolute junction temperature T_i as well as a temperature gradient resulting of a power stage that heats up too fast. Activation of any of the temperature sensors will cause an overheated channel to switch off to prevent destruction. Any protective overtemperature shutdown event triggered by an overheated channel switches off the output until the temperature reaches an acceptable value again.

A restart functionality is implemented that switches the channel on again after the DMOS temperature has sufficiently cooled down.

$35\ m\Omega$ single channel smart high-side power switch



Protection functions

Electrical characteristics: Protection functions 7.6

Electrical Characteristics: Protection Functions 1) Table 6

 $V_{\rm S}$ = 8 V to 36 V, $T_{\rm i}$ = -40°C to 150°C (unless otherwise specified)

Typical values are given at $V_S = 24 \text{ V}$, $T_j = 25 ^{\circ}\text{C}$

Parameter	Symbol	Values			Unit	Note or	Number
		Min.	Тур.	Max.		Test Condition	
Loss of Ground		1	<u>, </u>	, ,			
Output leakage current while GND disconnected	I _{OUT(GND)}	_	0.1	-	mA	²⁾ V _S = 24 V	P_7.6.1
Reverse Polarity		1	<u>, </u>	, ,			
Drain source diode voltage during reverse polarity	$V_{\rm DS(REV)}$	_	650	700	mV	$I_{L} = -2 \text{ A};$ $T_{j} = 150^{\circ}\text{C};$	P_7.6.2
Overvoltage							
Overvoltage protection	$V_{S(AZ)}$	65	70	75	٧	$I_{SOV} = 5 \text{ mA}$	P_7.6.3
Current limitation							
Allowed I _{OCT} range for adjusting current limit threshold I _{LIM(th,adj)}	I _{OCT_range}	6.67	-	120	μΑ	2) _	P_7.6.4
OCT-pin voltage V _{OCT} (in ON- state)	V _{OCT}	-	0.5	-	V	$V_{IN} = high;$ $V_S < V_{S(OV)_RS};$ $6.67 \mu A \le I_{OCT} \le 120 \mu A$	P_7.6.16
Current limitation with sett	ing	.67 μΑ (correspo	nds to R _{oo}	_{CT} > 75 k	(Ω)	
Current limit when OCT-pin is detected open	I _{LIM_int(MIN)}	-	2.63	-	А	2) 5)	P_7.6.46
Current limitation with sett	ing	.67 μΑ (correspo	nds to R _{oo}	_{:T} = 75 k	(Ω)	
Current limitation $I_{LIM} = I_{LIM} (I_{OCT} = 6.67 \mu A)$	I _{LIM}	2.00	3.02	4.06	A	$I_{OCT} = 6.67 \mu A$ $(R_{OCT} = 75 kΩ);$ $25^{\circ}C \le T_{j} \le 150^{\circ}C$	P_7.6.19
Current limitation $I_{LIM} = I_{LIM} (I_{OCT} = 6.67 \mu A)$	I _{LIM}	1.78	3.09	4.37	Α	$I_{\text{OCT}} = 6.67 \mu\text{A}$ $(R_{\text{OCT}} = 75 \text{k}\Omega);$ $T_{\text{j}} = -40^{\circ}\text{C}$	P_7.6.35
Current limitation with sett	ing	7.47 μΑ	(corresp	onds to R	_{OCT} = 18	.2 kΩ)	
Current limitation $I_{LIM} = I_{LIM} (I_{OCT} = 27.47 \mu A)$	I _{LIM}	3.28	4.58	5.85	A	I_{OCT} = 27.47 μA $(R_{OCT}$ = 18.2 kΩ); 25°C ≤ T_j ≤ 150°C	P_7.6.37
Current limitation $I_{LIM} = I_{LIM} (I_{OCT} = 27.47 \mu A)$	I _{LIM}	3.32	5.00	6.58	A	$I_{\text{OCT}} = 27.47 \mu\text{A}$ $(R_{\text{OCT}} = 18.2 \text{k}\Omega);$ $T_{\text{j}} = -40^{\circ}\text{C}$	P_7.6.38

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Protection functions

Table 6 Electrical Characteristics: Protection Functions 1) (cont'd)

 $V_{\rm S}$ = 8 V to 36 V, $T_{\rm i}$ = -40°C to 150°C (unless otherwise specified)

Typical values are given at $V_S = 24 \text{ V}$, $T_i = 25 ^{\circ}\text{C}$

Parameter	Symbol		Values	5	Unit	Note or Test Condition	Number
		Min.	Тур.	Max.			
Current limitation with sett	ing	0 μΑ (co	rrespond	s to R _{OCT}	= 10 kΩ	2)	,
Current limitation (AMB & HOT) $I_{LIM} = I_{LIM}(I_{OCT} = 50.0 \mu A)$	I _{LIM}	4.97	6.65	8.32	A	$I_{OCT} = 50.0 \text{ μA}$ $(R_{OCT} = 10 \text{ k}\Omega);$ $25^{\circ}\text{C} \leq T_{j} \leq 150^{\circ}\text{C}$	P_7.6.22
Current limitation $I_{LIM} = I_{LIM}(I_{OCT} = 50.0 \mu A)$	I _{LIM}	5.25	7.40	9.47	A	$I_{\text{OCT}} = 50.0 \mu\text{A}$ $(R_{\text{OCT}} = 10 \text{k}\Omega);$ $T_{\text{j}} = -40^{\circ}\text{C}$	P_7.6.41
Current limitation with sett	ing I _{oct} ≥ 9	7.85 μΑ	(correspo	onds to R	_{ост} ≤ 5. .	11 kΩ)	
Current limit when OCT-pin is shorted to GND-pin or $I_{\rm OCT}$ exceeding upper specified range	I _{LIM_int(MAX)}	10.00	13.20	15.85	A	2) 5) 6) $I_{OCT} \ge 97.85 \mu\text{A};$ $(R_{OCT} \le 5.11 \text{k}\Omega)$ 25°C ≤ $T_i \le 150$ °C	P_7.6.6
Current limit when OCT-pin is shorted to GND-pin or I_{OCT} exceeds upper specified range	I _{LIM_int(MAX)}	10.50	14.00	16.30	A	2) 5) 6) $I_{OCT} \ge 97.85 \mu\text{A};$ $(R_{OCT} \le 5.11 \text{k}\Omega)$ $T_j = -40^{\circ}\text{C}$	P_7.6.45
Thermal Protection					•		<u>.</u>
Dynamic thermal shutdown protection threshold (temperature gradient within IC)	$T_{\rm j(SW)}$	_	80	_	K	2) _	P_7.6.8
Thermal shutdown temperature (absolute T_J)	$T_{j(SC)}$	150	175	200	°C	2) _	P_7.6.10
Thermal shutdown hysteresis	$\Delta T_{\rm j(SC)}$	-	30	-	К	2) _	P_7.6.11

- 1) Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Integrated protection functions are designed to prevent IC from destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are designed neither for continuous nor repetitive operation
- 2) Not subject to production test; specified by design
- 3) During transient overvoltage events the current through the GND path needs to be limited. It is recommended to place a resistor in the range of \geq 27 Ω into the GND path if transient overvoltage events have to be considered in the application
- 4) Test at $T_i = 150$ °C
- 5) Please note that operation above allowed I_{OCT} range is considered as fault condition and will be flagged on the ST-pin. For further details please refer to **Chapter 9.1** and **Chapter 9.3**
- 6) Without a properly dimensioned R_{OCT} the device can be damaged under reverse polarity condition

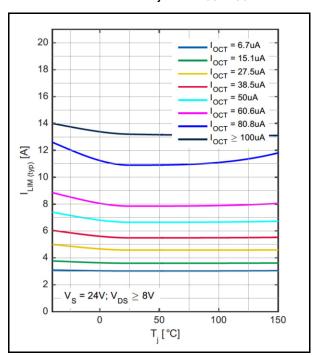


Protection functions

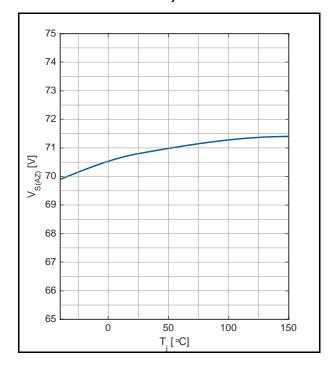
Typical performance characteristics protection functions 7.7

Typical performance characteristics

Current limit $I_{LIM(th,adj)}$ versus junction temperature T_j (as $f(R_{OCT}, I_{OCT})$



Clamping voltage $V_{\rm S(AZ)}$ versus junction temperature T_i



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Discharge functionality

8 Discharge functionality

8.1 Discharge functionality

The discharge feature of ITS6035S-EP-K offers a transient discharge path to device ground. It is realized with a dedicated pin (DC-pin) and a pull-down circuit to device GND, as shown in **Figure 23**. If the usage of the DC feature is desired, the output pins (OUT) need to be connected externally to the DC-pin (see more detailed explanation below). If the functionality is not needed, the DC-pin can be left open or tied with a serial resistor to device GND.

As long as the device is in ON-state, the DC function is inactive and the impedance of DC-pin is HiZ. The DC-pin can be used for a faster discharge of the output or as a trigger signal for external discharge circuits.

The discharge functionality is triggered automatically when the channel is switched off and is active for a duration of t_{DC} .

After channel deactivation, there are two ways the discharge is triggered internally

- Drain-source voltage, V_{DS} of the DMOS falls below the threshold $V_{DS_DC_on}$
- After the time-out delay, $t_{SW(OFF)_TO}$, in case the $V_{DS_DC_on}$ threshold had not been reached previously Both options are shown in **Figure 24**.

The DC function is only activated if no other discharge event occurs within the activation window. If within the activation window, $V_{\rm DS_DC_on}$ threshold is reached multiple times, the $t_{\rm DC}$ duration is reset each time. This means that ongoing discharge event is prolonged by $t_{\rm DC}$. This reduces potential oscillations on the output more effectively. After $t_{\rm SW(OFF)_TO}$ is expired, no further activations of the discharge function are triggered until the channel gets reactivated. The typical averaged discharge current capability of the DC-pin is specified as $I_{\rm DC_sink}$. After $t_{\rm DC}$ has expired the DC-pin becomes HiZ, until it is triggered again.

Any change of the input level of the IN-pin from low to high that switches the channel into ON-state will immediately interrupt an ongoing discharge event and the DC-pin will become HiZ again. A timing overview of the DC-pin functionality is summarized in **Figure 24** and **Table 7**.

During ON-state the DC-pin remains always HiZ. If the device shuts off due to an overvoltage event and enters the OVLO active mode, the DC-pin will not become active. Ongoing discharge events are immediately terminated if a voltage above the OVLO threshold is detected by the device.

When the DC-pin is used to discharge the output, it is mandatory to place an external diode, $D_{\rm DC}$, between OUT and DC-pin to avoid interferences between the DC-pin and the active clamping mechanism of the IC. $D_{\rm DC}$ blocks the current through the body diode of the discharge FET during switching off inductive loads. Without the diode the intended operation could be disturbed, the switch off timings could be influenced and the discharge path could be overstressed and damaged. In addition, this diode ensures proper loss of GND protection when using the DC-pin to discharge the output. For any use case where the DC-pin could be pulled below device GND during operation, the diode $D_{\rm DC}$ has to be used.

Note: Please take note that the presence of the D_{GND} does not mean that the blocking diode D_{DC} can be excluded.

In addition, depending on the output voltage, a resistor, $R_{\rm DC}$, must be placed in series to the diode in order to limit the power dissipation inside the discharge circuit of the IC. The value of the resistor must be chosen in a



Discharge functionality

way that the voltage drop over the DC-pin is limited to V_{DC_act} . The formula for calculating the discharge resistor R_{DC} is shown in **Equation (8.1)**.

$$R_{DC} = \frac{V_{OUT} - V_{DC_act}}{I_{DC_sink}}$$
(8.1)

Note: For 24 V applications the recommended value for R_{DC} is ≥ 50 Ohm.

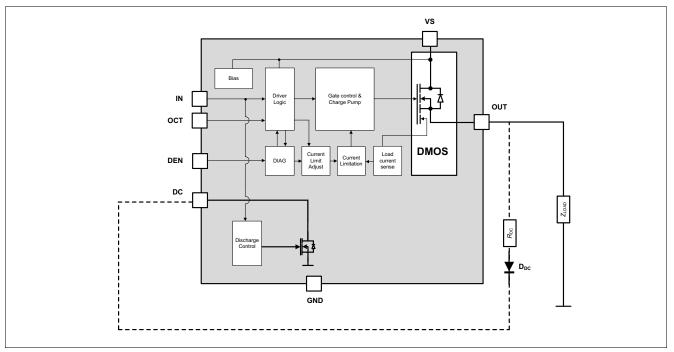


Figure 23 Discharge pin functionality

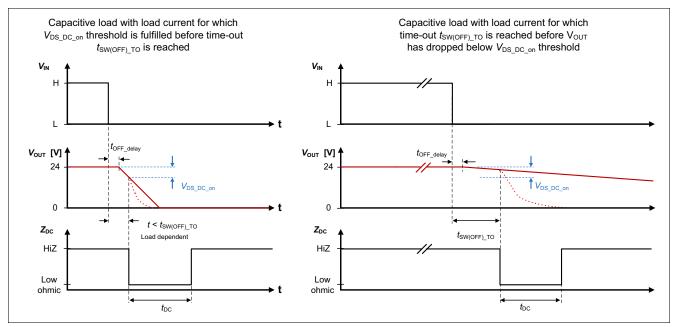


Figure 24 Dynamic timing behavior discharge pin (dashed lines indicate possible examples of the output voltage when DC-pin used to discharge output)

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Discharge functionality

Dynamic DC-pin activation /deactivation after switching of the channel during normal Table 7 operation

IN	Criteria when DC - path becomes active / inactive	I_{DC_sink} ($T_j = 25^{\circ}C;$	Duration	Comment
	after trigger event	V _{DC_act} ~ 20 V)		
Н	-	- (HiZ)	static	In ON-state (active mode) DC-pin remains always HiZ
H→L	When $V_{\rm DS}$ reaches $V_{\rm DS_DC_on}$ but latest after $t_{\rm SW(OFF)_TO}$ following a negative IN edge	~ 145 mA	$t_{ extsf{DC}}$	Channel being switched off triggers a discharge event of duration $t_{\rm DC}$
L → H	$t_{ m DC_off}$	– (HiZ)	static	Switching channel on will stop any potentially ongoing discharge event

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Discharge functionality

Electrical characteristics: Discharge pin 8.2

Electrical characteristics: Discharge pin Table 8

 $V_{\rm S}$ = 8 V to 36 V, $T_{\rm i}$ = -40°C to 150°C (unless otherwise specified) Typical values are given at $V_S = 24 \text{ V}$, $T_i = 25 ^{\circ}\text{C}$

Parameter	Symbol	Values			Unit	Note or	Number
		Min.	Тур.	Max.		Test Condition	
DC-pin currents			J.	<u> </u>	'		1
Current sink capability of active DC-pin (from DC-pin to device GND) 1)	I _{DC_sink}	80	145	160	mA	2) $25^{\circ}C \le T_{j} \le 150^{\circ}C$ $V_{DC_act} < V_{S}$	P_8.2.1
Current sink capability of active DC-pin (from DC-pin to device GND) 1)	I _{DC_sink}	-	170	-	mA	10 V $\leq V_{DC_inact} \leq$ 20 V; $T_j = -40^{\circ}C;$ $V_{DC_act} \leq V_S$	P_8.2.8
DC-pin leakage current when inactive (from DC-pin to device GND)	I _{DC_leakage}	_		5	uA	$V_{\rm S} = V_{\rm DC_inact} \le 30 \rm V;$ (DC-pin inactive for at least 500 us)	P_8.2.9
DC-pin timings and threshol	d						
V_{DS} drain-source voltage threshold for activation of discharge pin (after transition IN H \rightarrow L)	V _{DS_DC_on}	-	3	-	V	2) 3) 4) V _S = 24 V	P_8.2.6
Discharge duration (DC - pin conductive) after activation	t_{DC}	150	250	410	μs	V _S = 24 V	P_8.2.3
Deactivation delay of an ongoing discharge event interrupted by IN L → H transition	t _{DC_off}	-	3	-	μs	2) _	P_8.2.4

- 1) For the duration $t_{\rm DC}$ after trigger event
- 2) Not subject to production test; specified by design
- 3) Value of $V_{\rm DS_DC_on}$ is depending on actual load conditions
- 4) Parameter applies inside a time window from the falling IN edge to $t_{\rm SW(OFF)_TO}$. If $V_{\rm DS}$ has not crossed the threshold $V_{\rm DS\ DC\ on}$ within this window the DC-pin will be activated at time $t_{\rm SW(OFF)\ TO}$ after the falling IN edge

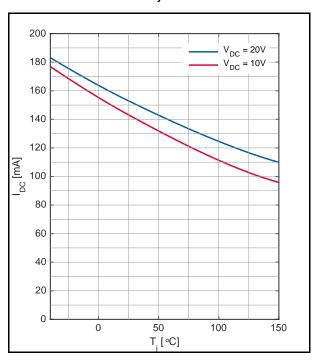


Discharge functionality

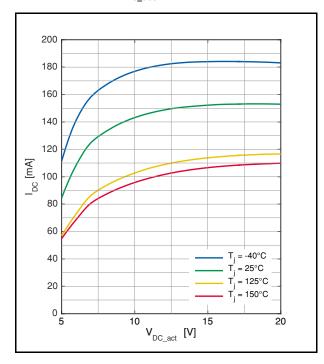
8.3 Typical performance characteristics: Discharge pin

Typical performance characteristics

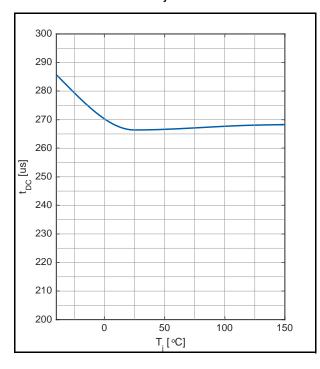
DC-pin sink current I_{DC_sink} (during t_{DC}) versus junction temperature T_i



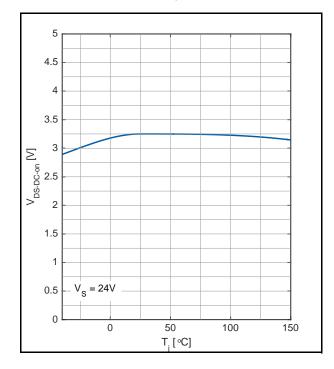
DC-pin sink current I_{DC_sink} versus DC-pin voltage V_{DC_act}



Discharge duration t_{DC} versus junction temperature T_i



Discharge activation threshold $V_{\rm DS_DC_on}$ versus junction temperature $T_{\rm J}$



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Diagnostic functions

9 Diagnostic functions

The ITS6035S-EP-K is able to provide detailed diagnosis information during operation. The diagnosis information can be split into basic diagnosis and extended diagnosis. The basic diagnosis is continuously monitored during the ON-state of the device and given as digital signal to the user via the ST-pin. The only basic diagnosis that is monitored in both, ON-state and OFF-state is the overvoltage lockout detection.

The basic diagnosis comprises:

- Overload/short circuit to GND
- Overtemperature (during ON-state)
- Persisting overvoltage leading to an OVLO event (during ON-state and OFF-state)
- Violation of minimum allowed R_{OCT} (e.g. OCT-pin shorted to GND)

In addition to the basic diagnosis there is also an extended diagnosis that needs to be requested by the DENpin.

The extended diagnosis comprises:

- Analog sense current information on IS-pin during ON-state under nominal operation conditions (can also be useful for open load detection during ON-state). In case of overload or short circuit a fault current will be provided instead of the proportional sense current as long as DEN remains high and the device does not enter thermal shutdown
- Digital open load detection during OFF-state (in combination with external pull-up resistor)
- Digital feedback on Short to V_S during OFF-state (in combination with external pull-down resistor)
- · Overtemperature during OFF-state
- I_{OCT} is monitored continuously in ON-state. If I_{OCT} > I_{OCT(short2GND)}, a fault state is flagged on ST during ON-state as long as DEN = low. In order to be able to distinguish this specific fault condition from overtemperature and overload or overvoltage faults, this flag is blanked if DEN is set to high but re-flagged if DEN is set to low again in case the fault condition persists, as shown in Table 9

The analog portion of the extended diagnosis (i.e. current sense information during ON-state) as well as the fault current during overload is provided by the IS-pin while all other digital diagnostic information of the extended diagnosis mode (i.e. during OFF-state) is flagged on the ST-pin. **Figure 25** and **Figure 26** illustrate the timings of basic and extended diagnosis functionality while **Figure 27** shows a simplified application example.

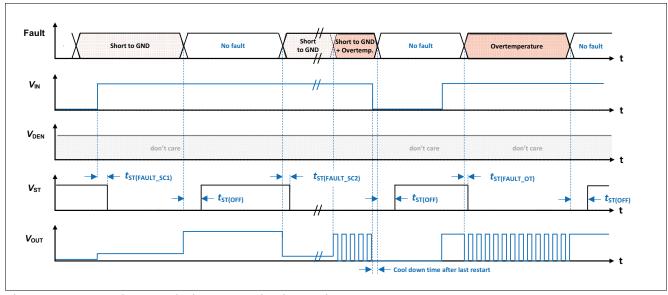
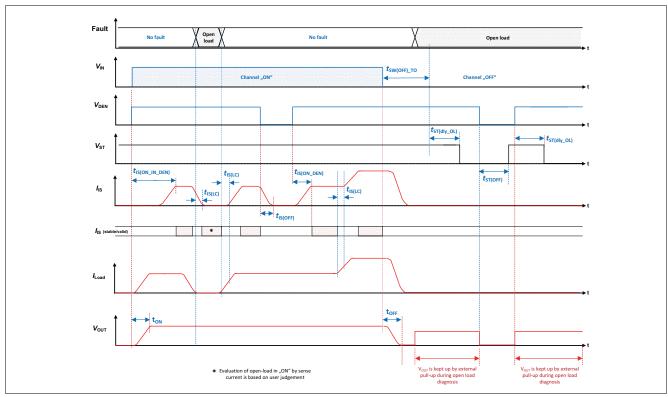


Figure 25 Behavior and timings of basic diagnosis



Diagnostic functions



Behavior and timings of the extended diagnostic capabilities (the usage of a DEN -Figure 26 controlled switchable pull-up resistor from OUT to V_s in OFF-state is assumed)

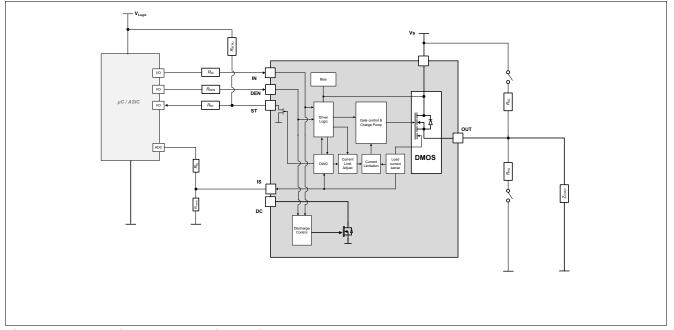


Figure 27 Overview: usage of diagnosis

Digital status flag ST (STATUS) 9.1

The ITS6035S-EP-K provides a digital signal for diagnostic information on the ST-pin. This signal is called STATUS. The ST-pin is realized as open drain output and must be connected to an external pull-up resistor to either logic supply or to V_s . During normal operation the STATUS signal is logic high (H). When the device is in ON-state the presence of the fault conditions short circuit to ground, overtemperature, overvoltage lockout or

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Diagnostic functions

a violation of the allowed minimum resistance of $R_{\rm OCT}$ is flagged by a logic low (L) level on the ST-pin. **Table 9** shows the truth table of the ST-pin output. During the OFF-state of the device the ST-pin is flagging only the presence of an overvoltage lockout by default (i.e. independent of the state of DEN). In addition the extended diagnosis information for detection of open load is also flagged on the ST-pin during OFF-state indicating the presence of an open load condition (OL) in OFF. Open load in OFF-state will be flagged on the ST only after the blanking time $t_{\rm ST(dly_OL)}$ has elapsed which means after the device has been monitored in this fault condition continuously throughout the blanking time. The blanking time counter for $t_{\rm ST(dly_OL)}$ is always started with the rising DEN edge except directly after switching off the channel. After switching off the channel the open load blanking time counter is started earliest after the switch off time-out delay $t_{\rm SW_OFF_TO}$. This means that an open load fault in OFF-state can be detected earliest after $t_{\rm SW_OFF_TO} + t_{\rm ST(dly_OL)}$ referenced to the falling IN edge (for details see also **Figure 26**). The open load detection in OFF-state is realized by a voltage comparator at the output. If the output voltage is staying or getting closer to $V_{\rm S}$ than a threshold ($V_{\rm S} - V_{\rm OUT(OL)}$) for a duration of t > $t_{\rm ST(dly_OL)}$ the flag is set. This means that for open load detection in OFF-state an external pull-up resistor to $V_{\rm S}$ must be applied. Adjusting the resistance of the pull-up resistor allows to adjust the desired open load criteria ¹⁾.

Open load diagnosis in OFF-state must be requested via the DEN signal. Without setting the DEN-pin to high no open load diagnosis is flagged on ST.

Table 9 Diagnostic truth table ST-pin

Condition	IN	DEN 1)	DMOS	ST ²⁾	Comment
ON-state	II.		П	1	
Normal Operation	Н	Х	ON	Н	
Short circuit to GND	Н	Х	ON	L	
³⁾ Overtemperature in ON-state	Н	Х	OFF 4)	L	
$\overline{ \begin{array}{c} \text{Overvoltage lockout event in ON-state} \\ (V_{\text{S}} \text{ overvoltage} > V_{\text{S(OV)_LO}} \text{ persisting for} \\ \text{t} > t_{\text{OV_BLK}}) \end{array} }$	Н	Х	OFF 5)	L	Overvoltage lockout becomes active after blanking time $t_{\rm OV_BLK}$ has elapsed
<i>I</i> _{OCT} exceeding the specified range (e.g. if OCT-pin is shorted to GND)	Н	L	ON	L	$^{6)}I_{OCT}$ is monitored continuously in ON-state. If $I_{OCT} > I_{OCT(short2GND)}$
	Н	Н	ON	Н	a fault state is flagged on ST during ON-state as long as DEN = low. In order to be able to distinguish this specific fault condition from overtemperature and overload or overvoltage faults this flag is blanked if DEN is set to high but re-flagged if DEN is set to low again in case the fault condition persists
Open load condition while device is in OFF-state	L	L	OFF	Н	Open load in OFF not diagnosed unless extended diagnosis requested by DEN = high

¹⁾ In the same manner also short circuit to V_S can be realized with a pull-down resistor. In both cases it is recommended to use pull-up or pull-down circuits that can be switched off while not being used to minimize power dissipation

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Diagnostic functions

Table 9 Diagnostic truth table ST-pin (cont'd)

Condition	IN	DEN 1)	DMOS	ST ²⁾	Comment
⁷⁾ Open load condition while device is in OFF-state	L	Н	OFF	L	$^{8) \; 9)}$ Requires external pull-up attached from OUT to $V_{\rm S}$
OUT shorted to $V_{\rm S}$ while device is in OFF-state	L	Н	OFF	L	^{8) 9)} Requires external pull-down attached from OUT to GND
Overtemperature in OFF-state	L	Н	OFF	L	-
Overvoltage lockout event in OFF-state $(V_{\rm S} > V_{\rm S(OV)_LO} \text{ persisting for t} > t_{\rm OV_BLK})$	L	X	OFF	L	OVLO is continuously monitored also in OFF-state independent of DEN
Any fault condition except OVLO while being in OFF-state with DEN = low	L	L	OFF	Н	-

- 1) "X" denotes that logic level of DEN is irrelevant ("don't care")
- 2) External pull-up resistor needs to be placed at ST-pin
- 3) This fault condition can be caused by both a violation of the maximum allowed T_j but as well by exceeding the maximum allowed temperature gradient $T_{i(SW)}$ within the IC
- 4) Automatic restart after T_i has sufficiently cooled down
- 5) Automatic restart after overvoltage event has cleared
- 6) Please note that $t_{ST(OFF)}$ will apply when DEN is set from low to high until ST-flag for indicating l_{OCT} being above the limit is cleared
- 7) Diagnosis of open load in OFF-state and diagnosis of OUT shorted to V_S cannot be evaluated simultaneously. If both diagnosis features are applied in the same application the corresponding required external pull-up or pull-down circuits must be controlled with external switches
- 8) Flag will be set after blanking time $t_{\rm ST(dly_OL)}$ has elapsed
- 9) Please note that for this fault condition the ST flag is reset directly after the fault situation has cleared. $t_{ST(OFF)}$ does not apply

9.2 Analog current sense pin, IS

In addition to the digital diagnosis STATUS output there is the current sense pin, IS that provides extended analog diagnosis information about the load current flowing through the power stage during ON-state. This extended diagnosis information must be requested by a high level High on the DEN input pin. Without a high level on the DEN-pin, the current sense-pin functionality is disabled and the IS-pin becomes high impedance. During the time the IS-pin functionality is enabled, the IS-pin will provide a sense current signal $l_{\rm IS}$ proportional to a fraction of the load current defined by the k_{ILIS} factor: $I_{IS} = I_L/k_{ILIS}$. The proportional sensing of the load current via I_{IS} can be achieved for output currents up to the range where the adjusted current limitation function is becoming active. Once the device is in current limitation mode I_{OUT} cannot be sensed proportionally anymore and a fault current $I_{\text{IS(FAULT)}}$ will be provided instead. By this fault current the user can gain information whether a current is flowing through the power stage also during fault situations. The $I_{\rm IS(FAULT)}$ that is provided while the device is in overload will be stopped if the power stage is switched off by reaching thermal shutdown 1) or if DEN is pulled to low by the user. The magnitude of the fault current itself however will not be related to the adjusted current limitation but always be a more or less fix value 2) that is higher than the sense current signal during normal operation. The transition between the proportional sensing range (= nominal current range) and the non-proportional fault current range is immediately flagged by a low signal on the digital status pin in order that the user knows at any time how to interpret the sense result. The digital

¹⁾ If the DMOS restarts after a cool down period, the $I_{\text{IS(FAULT)}}$ will be also be restarted as long as the extended diagnosis functionality remains activated by DEN

²⁾ The absolute value of $I_{IS(FAULT)}$ may vary with process and temperature

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Diagnostic functions

flag of an overload condition on the ST-pin is always set independent of the current sense feature. The behavior of the IS-pin during overload and overtemperature is illustrated in **Figure 28**.

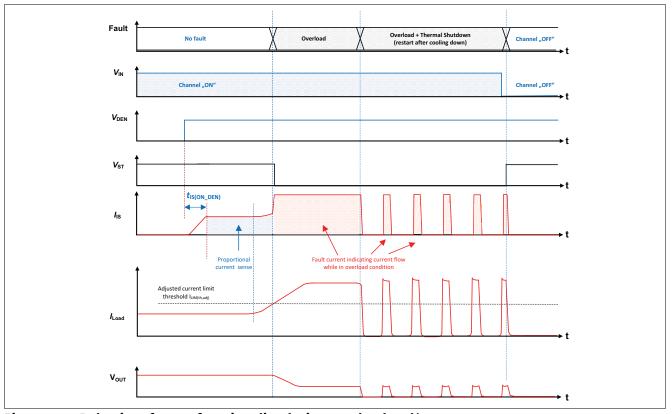


Figure 28 Behavior of sense functionality during overload and/or overtemperature

The truth table summarizing the behavior of the sense functionality is shown in **Table 10**. A sketch how to apply the current sense feature is shown in **Figure 27**: The IS-pin is connected via an external resistor $R_{\text{SENSE}}^{1)}$ to module ground. The sense current will cause a voltage drop on R_{SENSE} that can be measured by an A/D-pin of a microcontroller. It hence can also be used for diagnosis of open load during ON-state as well as to monitor undesired high load conditions even before the adjusted current limitation threshold is reached.

The accuracy of the sense current in the proportional range depends on the temperature T_j as well as on the magnitude of the load current itself. The accuracy of the sense current versus load current is illustrated in Figure 29.

Table 10 Diagnostic Truth Table IS-pin

Load condition	IN	DEN	OUT	IS	Comment
All operation modes during ON (ranging from open load, normal operation up to overload/short circuit)	Н	L	ON	I _{IS} = 0	No analog sense information when being deactivated by DEN = low
Normal operation during ON (ranging from open load, normal operation until overload/short circuit detection is reached	Н	Н	ON	$I_{\rm IS} \sim I_{\rm L} / k_{\rm ILIS}$	Proportional sense current will be sourced for $I_{\text{OUT}} < I_{\text{LIM}}$

¹⁾ A recommended value for R_{SENSE} is 1.2 k Ω

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Diagnostic functions

Table 10 Diagnostic Truth Table IS-pin (cont'd)

Load condition	IN	DEN	OUT	IS	Comment
Device in overload/short circuit	Н	Н	ON	$I_{\rm IS} = I_{\rm IS(FAULT)}$	While in current limitation a digital fault current $I_{\text{IS(FAULT)}}$ is provided by the IS-pin instead of a proportional sense current. When entering overload fault condition the ST flag is set immediately to low to report short circuit fault and at the same time indicate that the sense result exits the proportional range
Device in overtemperature/ thermal shutdown	Н	Н	OFF	I _{IS} = 0	Overtemperature is not flagged by ISpin: the occurrence of an overtemperature event will stop any ongoing sense current or fault current: If an overload condition is causing a fault current it will be stopped as soon as thermal shutdown is reached. If the device has cooled down and tries to restart also the sense functionality (either sense current or fault current) will restart again as well (see also Figure 28)
All operation modes during off (including open load or short to V_S)	L	X	OFF	I _{IS} = 0	1) No current sense information available during OFF-state

¹⁾ All diagnosis information during OFF-state (open load/OVLO) is flagged on ST-pin only

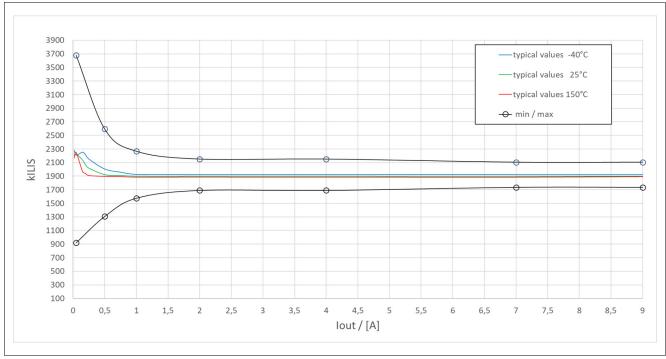


Figure 29 k_{ILIS} ratio of sense current I_S as function of the load current

$35\ m\Omega$ single channel smart high-side power switch



Diagnostic functions

Electrical characteristics: Diagnostic functions (ST-pin and IS-pin) 9.3

Electrical characteristics: Diagnostic functions

 $V_{\rm S}$ = 8 V to 36 V, $T_{\rm i}$ = -40°C to 150°C (unless otherwise specified) Typical values are given at $V_S = 24 \text{ V}$, $T_i = 25 ^{\circ}\text{C}$

Parameter	Symbol	Values			Unit	Note or	Number	
		Min.	Тур.	Max.		Test Condition		
Basic diagnostics (ST-pin)	ı			<u> </u>				
Status settling time for channel start-up into existing overload ¹⁾ (from IN slope to ST low)	t _{ST(FAULT_SC1)}	-	50	-	μs	<i>V</i> _{DS} ≥ 5 V	P_9.4.1	
Status settling time for channel entering short circuit condition during ON-state (from point where SC is reached to ST low)	t _{ST(FAULT_SC2)}	_	25	_	μs	$^{2)}V_{DS} \ge 5V$	P_9.4.2	
Status settling time for over- temperature indication on ST- pin	$t_{ST(FAULT_OT)}$	-	5	-	μs	2) _	P_9.4.3	
Status blanking time for open load detection (device in stable OFF-state)	$t_{\rm ST(dly_OL)}$	-	130	-	μs	-	P_9.4.4	
3) Time-out before status blanking delay timer for open load diagnostics can be started after entering OFF-state	t _{SW(OFF)_TO}	-	195	260	μs	_	P_9.4.34	
Status reset blanking time	t _{ST(OFF)}	-	120	-	μs	2) _	P_9.4.26	
Low level status voltage	$V_{\rm ST(L)}$	_	-	0.5	V	4) I _{ST} = 1.6 mA	P_9.4.5	
Open load detection voltage threshold in OFF-state	V _S - V _{OUT(OL)}	4	4.45	6	V	$V_{IN} = low;$ $V_{DEN} = high$	P_9.4.10	
OCT-pin short to ground detection threshold in ON-state	I _{OCT(short2GND)}	150	-	240	μА	V _{IN} = high; V _{DEN} = low; V _{OCT} exceeding allowed range to higher values (ST will go from high to low	P_9.4.30	

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Diagnostic functions

Electrical characteristics: Diagnostic functions (cont'd)

 $V_{\rm S}$ = 8 V to 36 V, $T_{\rm j}$ = -40°C to 150°C (unless otherwise specified) Typical values are given at $V_S = 24 \text{ V}$, $T_j = 25 ^{\circ}\text{C}$

Parameter	Symbol		Value	S	Unit		Number
		Min.	Тур.	Max.		Test Condition	
OCT-pin short to ground reset threshold in ON-state (hysteresis)	I _{OCT(S2G_reset)}	-	175	-	μА	V _{IN} = high; V _{DEN} = low; V _{OCT} going from fault range to pass range (ST will go from low to high	P_9.4.37
Sense-pin (IS) diagnostics			1		1		-
IS-pin leakage current when sense is disabled	I _{IS(off)}	_	_	1	μΑ	V_{IN} = high; V_{DEN} = low; I_L = 2 A	P_9.4.11
IS-pin leakage current	I _{IS(EN)}	_	0.3	2.5	μΑ	V_{IN} = high; V_{DEN} = high; I_{L} = 0 A	P_9.4.31
Sense signal saturation voltage	V _S - V _{IS(range)}	1.5	-	3.5	V	V_{IN} = high; $V_{OUT} = V_{S} > 10 \text{ V};$ V_{DEN} = high; I_{IS} = 6 mA	P_9.4.12
Sense signal maximum voltage	$V_{\rm IS(AZ)}$	65	-	75	V	I _{IS} = 5 mA	P_9.4.13
IS-pin fault current during overload condition	I _{IS} (fault)	5.7	-	35	mA	V _{IN} = high; V _{DEN} = high; device in overload condition	P_9.4.33
Current sense settling time of $k_{\rm ILIS}$ functionality after transition from OFF-state to ON-state to 90% of static $I_{\rm IS}$ value (positive slope on both IN and DEN)	t _{IS(ON_IN_DEN)}	-	-	350	μs	$V_{\text{IN}} = V_{\text{DEN}}$ going from low to high; $R_{\text{SENSE}} = 1.2 \text{ k}\Omega$; $C_{\text{SENSE}} < 100 \text{ pF}$; $R_{\text{L}} = 12 \Omega$; see Figure 26 ;	P_9.4.14
Current sense settling time of <i>I</i> _{IS} after DEN-pin transition from L-state to H while device is in ON-state	t _{IS(ON_DEN)}	-	-	10	μs	$V_{\rm S}$ = 24 V; $V_{\rm IN}$ = high; $V_{\rm DEN}$ going from low to high; $R_{\rm SENSE}$ = 1.2 k Ω ; $C_{\rm SENSE}$ < 100 pF; $R_{\rm L}$ = 12 Ω ; see Figure 26	P_9.4.15

$35\ m\Omega$ single channel smart high-side power switch



Diagnostic functions

Electrical characteristics: Diagnostic functions (cont'd) Table 11

 $V_{\rm S}$ = 8 V to 36 V, $T_{\rm j}$ = -40°C to 150°C (unless otherwise specified) Typical values are given at $V_S = 24 \text{ V}$, $T_j = 25 ^{\circ}\text{C}$

Parameter	Symbol		Value	s	Unit	Note or Test Condition	Number
		Min.	Тур.	Max.			
Current sense settling time of $I_{\rm IS}$ after load jump in ON-state	t _{IS(LC)}	-	20	-	μs	$V_{\rm S} = 24 \text{ V};$ $V_{\rm IN} = V_{\rm DEN} = \text{high};$ $R_{\rm SENSE} = 1.2 \text{ k}\Omega;$ $C_{\rm SENSE} < 100 \text{ pF};$ see Figure 26	P_9.4.16
$I_{\rm IS}$ diagnosis disable time after DEN transition from "H" to "L" ($I_{\rm IS}$ < 50% of $I_{\rm L}/k_{\rm ILIS}$)	t _{IS(OFF)}	-	-	20	μs	$V_{\rm S} = 24 \rm V;$ $V_{\rm IN} = \rm high;$ $V_{\rm DEN}$ going from high to low; $R_{\rm SENSE} = 1.2 \rm k\Omega;$ $C_{\rm SENSE} < 100 \rm pF;$ $R_{\rm L} = 12 \Omega;$ see Figure 26	P_9.4.17
Current sense ratio signal in no	minal area;	stable lo	ad curre	ent condi	tion		
Current sense ratio $I_{L50} = 50 \text{ mA}$	k _{ILIS_50}	-75%	2200	+75%	_	V _{IN} = high; V _{DEN} = high; after channel is ON-state for t > 350 μs	P_9.4.20
Current sense ratio $I_{L500} = 500 \text{ mA}$	k _{ILIS_500}	-25%	1930	+25%	-	V _{IN} = high; V _{DEN} = high; after channel is ON-state for t > 350 μs	P_9.4.21
Current sense ratio $I_{L1000} = 1 \text{ A}$	k _{ILIS_1000}	-15%	1910	+15%	-	V _{IN} = high; V _{DEN} = high; after channel is ON-state for t > 350 µs	P_9.4.22
Current sense ratio I _{L2000} = 2 A	k _{ILIS_2000}	-9.5%	1910	+9.5%	_	V _{IN} = high; V _{DEN} = high; after channel is ON-state for t > 350 µs	P_9.4.23
Current sense ratio I _{L4000} = 4 A	k _{ILIS_4000}	-9%	1910	+9%	-	V_{IN} = high V_{DEN} = high after channel is ON-state for t > 350 µs	P_9.4.24

35 m Ω single channel smart high-side power switch



Diagnostic functions

Table 11 Electrical characteristics: Diagnostic functions (cont'd)

 $V_{\rm S}$ = 8 V to 36 V, $T_{\rm j}$ = -40°C to 150°C (unless otherwise specified)

Typical values are given at $V_S = 24 \text{ V}$, $T_i = 25 ^{\circ}\text{C}$

Parameter	Symbol		Value	s	Unit	Note or Test Condition	Number
		Min.	Тур.	Max.			
Current sense ratio I _{L7000} = 7 A	k _{ILIS_7000}	-8%	1910	+8%	-	V _{IN} = high; V _{DEN} = high; after channel is ON-state for t > 350 μs	P_9.4.27
Current sense ratio $I_{L9000} = 9 \text{ A}$	k _{ILIS_9000}	-8%	1910	+8%	_	V _{IN} = high; V _{DEN} = high; after channel is ON-state for t > 350 μs	P_9.4.28

¹⁾ This parameter describes the status settling time when a channel is switched on into an already existing overload condition. This parameter is referenced to the edge of the input pin, IN that switches the channel into overload

²⁾ Not subject to production test, specified by design

³⁾ This time-out parameter applies also to trigger the discharge event of DC-pin if the V_{DS} based threshold $V_{DS_DC_on}$ has not been met up to this time - if the DC-pin functionality is used. For further details see also **Chapter 8.1**

⁴⁾ Levels referenced to device ground

⁵⁾ Level for open load detection in OFF referenced to V_s

⁶⁾ This fault is only reported as long as DEN = low

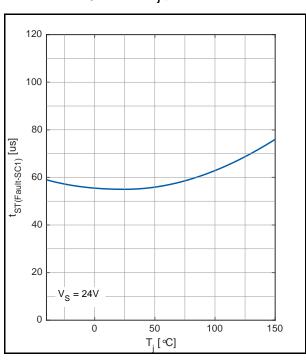


Diagnostic functions

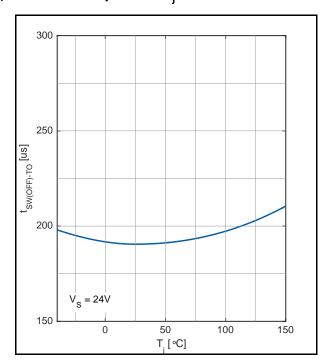
Typical performance characteristics: Diagnostic functions 9.4

Typical performance characteristics

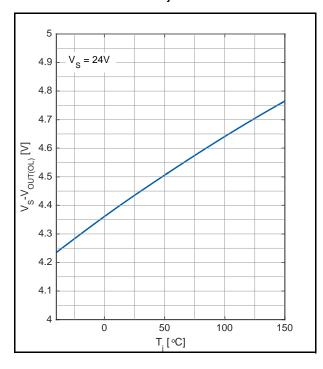
Status settling Time $t_{\text{ST(FAULT_SC1)}}$ versus Junction temperature T_i (switch on into overload) Junction temperature T_i



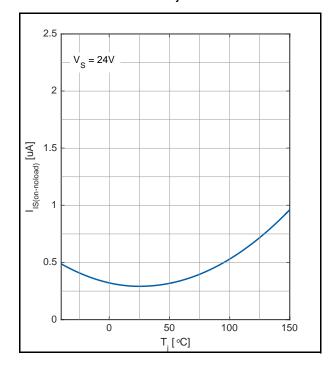
Time-out delay $t_{\rm SW(OFF)_TO}$ versus



Open load threshold $V_{\rm S}$ - $V_{\rm OUT(OL)}$ versus Junction temperature T_i



Sense current at no load $I_{\rm IS(on_noload)}$ versus Junction temperature T_i





Control input pins

10 Control input pins

10.1 Input pin circuitry of control pins (IN and DEN)

The IN-pin and DEN-pin circuitry are compatible with 3.3 V and 5 V microcontrollers as well as input levels up to V_S^{-1} . The concept of the input pin is to react to voltage thresholds which are referenced to device ground. An implemented Schmitt trigger avoids an undefined state if the voltage on the control pin is slowly increasing or decreasing. The output is either OFF or ON but cannot be in a linear or undefined state. The input circuitry of the control pins is compatible with PWM applications. **Figure 30** shows the electrical equivalent input pin circuitry.

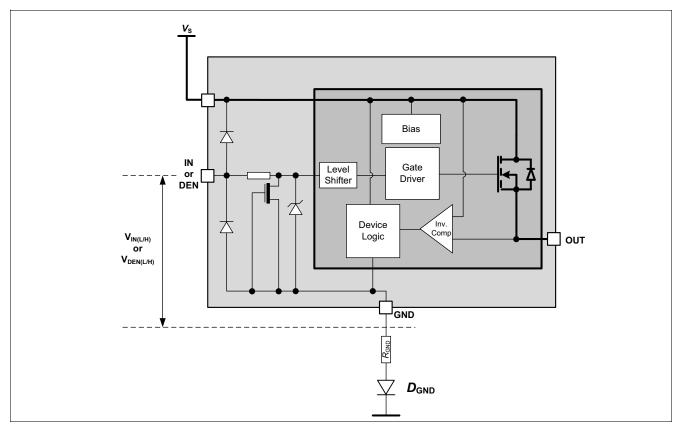


Figure 30 Input pin circuitry

10.2 Input pin voltage (IN and DEN)

The control pins IN and DEN use a comparator with hysteresis which is implemented in order to improve immunity to noise. Switching on/off of the channel takes place in a defined region, set by the thresholds $V_{\text{IN(L),MAX}}$ and $V_{\text{IN(H),MIN}}$.

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Control input pins

Electrical characteristics: Control input pins 10.3

Table 12 **Electrical characteristics: Input pins**

 $V_{\rm S}$ = 8 V to 36 V, $T_{\rm j}$ = -40°C to 150°C (unless otherwise specified) Typical values are given at $V_S = 24 \text{ V}$, $T_j = 25 ^{\circ}\text{C}$

Parameter	Symbol		Value	S	Unit	Note or Test Condition	Number
		Min.	Тур.	Max.			
Input pins characteristics	;						
Low level input voltage range	V _{IN(L)} V _{DEN(L)}	-0.3	-	0.8	V	1) _	P_10.3.1
High level input voltage range	$V_{\text{IN(H)}}$ $V_{\text{DEN(H)}}$	2	-	V _S	V	1) $V_{S} \ge V_{IN};$ $V_{S} \ge V_{DEN}$	P_10.3.2
Input voltage hysteresis	V _{IN(HYS)} V _{DEN(HYS)}	-	250	-	mV	2)_	P_10.3.3
Low level input current	I _{IN(L)} I _{DEN(L)}	-	35	70	μΑ	$V_{\rm IN} = 0.8 \text{ V}$ $V_{\rm DEN} = 0.8 \text{V}$	P_10.3.4
High level input current	I _{IN(H)} I _{DEN(H)}	-	35	70	μА	$V_{IN} = 24 V$ $V_{DEN} = 24 V$ $V_{S} \ge V_{IN}; V_{S} \ge V_{DEN}$	P_10.3.5

¹⁾ Levels referenced to device ground

²⁾ Not subject to production test; specified by design

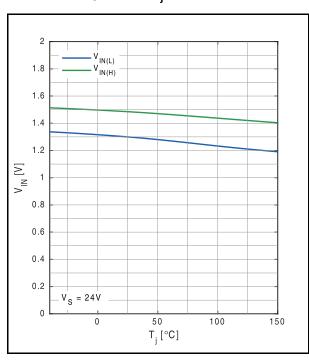


Control input pins

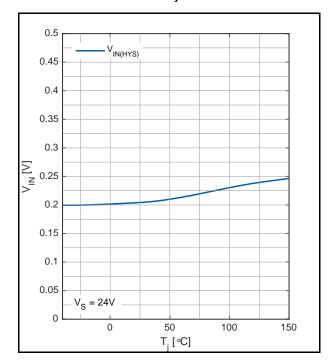
10.4 Typical performance characteristics: Input pins

Typical performance characteristics

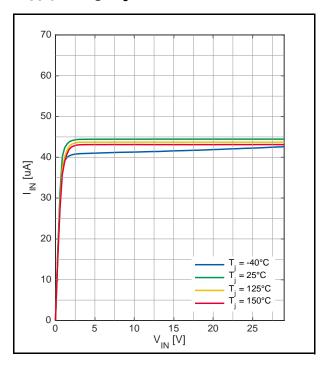
Input voltage thresholds $V_{\rm IN(L)}$ $V_{\rm IN(H)}$ versus Junction temperature $T_{\rm i}$



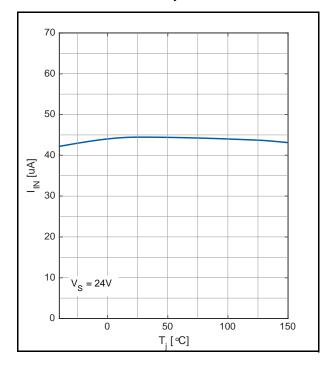
Input voltage hysteresis $V_{\rm IN(HYS)}$ versus Junction temperature $T_{\rm j}$



Input pin current $I_{IN(H)}$ versus Supply voltage V_S



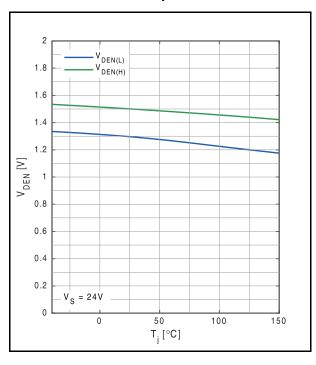
Input pin current $I_{IN(H)}$ versus Junction temperature T_i



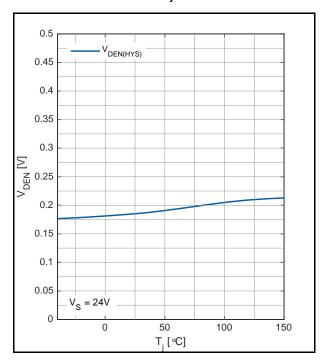


Control input pins

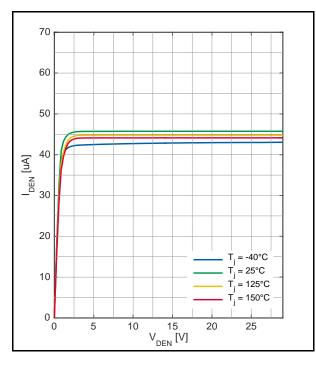
Input voltage thresholds $V_{\rm DEN(L)}$ $V_{\rm DEN(H)}$ versus Junction temperature $T_{\rm i}$



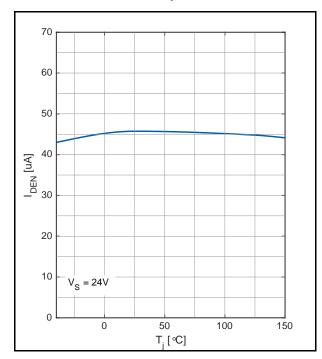
Input voltage hysteresis $V_{\text{DEN(HYS)}}$ versus Junction temperature T_{i}



Input pin current $I_{\mathrm{DEN(H)}}$ versus Supply voltage V_{S}



Input pin current $I_{\text{DEN(H)}}$ versus Junction temperature T_{j}





Application information

11 Application information

11.1 Application diagram

Note: This is a very simplified example of an application circuit. The function must be verified in the real

application.

Figure 31 and **Figure 32** show two simplified application examples where the ITS6035S-EP-K is directly controlled by logic levels of a microcontroller. In **Figure 32** the current limitation can be controlled by a microcontroller pin and the DC-pin is used to rapidly discharge the output after being switched off. The usage of a diode in the connection from DC-pin to OUT is mandatory. In both cases it is furthermore recommended to place serial input resistors at the interface pins to the microcontroller (IN/DEN) in order to protect the external control circuitry and the input structures of the ITS6035S-EP-K under fault conditions (e.g. reverse polarity, loss of ground or overvoltage).

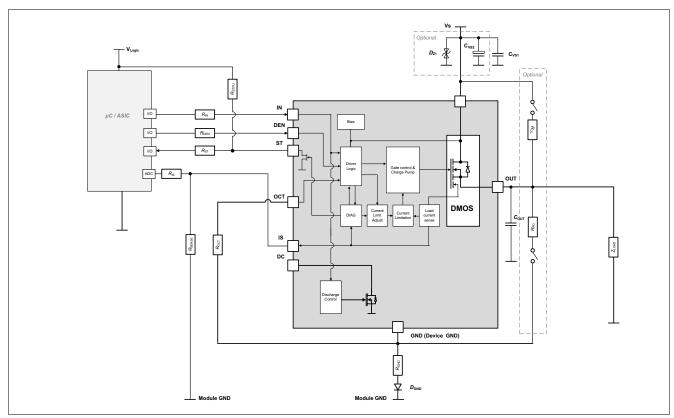


Figure 31 Application diagram with ITS6035S-EP-K



Application information

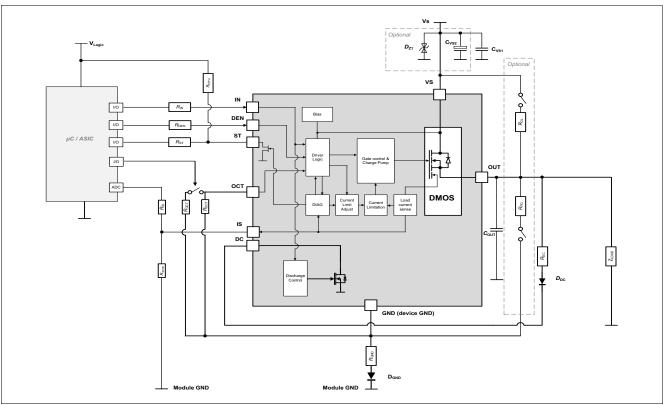


Figure 32 Application Diagram with ITS6035S-EP-K controlled by logic levels [μ C] with dynamic inrush current control and using DC-pin for discharging the output after switch off

11.2 External components for protection

Some of the features of the ITS6035S-EP-K require external components in order to work properly inside the application.

Table 13 Suggested component values

Reference	Value	Purpose		
R _{IN}	10 kΩ	Protection of the external control circuitry and the input structures under fault conditions (e.g. reverse polarity, loss of ground or overvoltage)		
R_{DEN}	10 kΩ	Protection of the external control circuitry and the input structures under fault conditions (e.g. reverse polarity, loss of ground or overvoltage)		
R_{ST}	10 kΩ	Protection of the external control circuitry and the input structures under fault conditions (e.g. reverse polarity, loss of ground or overvoltage)		
R_{STPU}	10 kΩ	Pull up resistor for open drain status output		
R _{IS}	10 kΩ	Protection during overvoltage, reverse polarity, loss of ground. Value to be tuned according to microcontroller specifications		
R _{SENSE}	1.2 kΩ	Sense resistor		
R _{OCT}	-	Adjustable overcurrent limitation resistor connected to device ground. Protection of the device during overvoltage and reverse polarity. Please refer to Table 14		
R_{GND}	27 Ω	To limit the GND current at a safe value during ISO pulse		
$\overline{D_{GND}}$	BAS21	Protection of the ITS6035S-EP-K during reverse polarity		

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Table 13 Suggested component values (cont'd)

Reference	Value	Purpose				
D _{Z1} 54 V TVS Diode		Transient voltage suppressor diode. Protection during overvoltage and in case of loss of supply while driving an inductive load				
C_{VS1}	100 nF	Filtering of voltage spikes on the supply line				
C_{VS2}	10 μF	Supply voltage buffer capacitor at supply				
R_{OL}	1.5 kΩ	Output polarization (pull-up). Ensure polarization of the output during open load in OFF diagnosis				
R_{PD}	47 kΩ	Output polarization (pull-down). Ensures polarization of the outputs to distinguish between open load and short to VS in OFF diagnosis				
C_{OUT}	10 nF	Protection of the output during ESD and BCI				
R_{DC}	51 Ω	Lower the power dissipation inside the device during discharge events				
D_{DC}	BAS21	Protection against reverse current flow from device GND				

11.2.1 Protection of GND path during fault conditions

During specific fault conditions the GND path of the device needs to be protected in order to avoid excessive stress to the device or potential destruction. The most important fault conditions are reverse polarity, transient overvoltage spikes or pulses that are exceeding the absolute maximum ratings of the device. The recommended GND protection in case of reverse polarity is to place a diode into the GND path. This solution is also depicted in the application diagrams. Reverse polarity cannot only be an issue in case of unintended wrong wiring of V_S and GND but may occur as well transiently in combination with pulses at VS or OUT.

If surge pulses (e.g. according IEC61000-4-5) have to be considered the usage of a TVS-protection diode at VS or a comparable protection device is mandatory because the energy content of such pulses is by far higher than what the ITS6035S-EP-K can absorb within the duration of the pulse. The chosen TVS diode for this purpose must provide a clamp voltage that is safely lower than the internal overvoltage clamp $V_{S(AZ)}$ of the ITS6035S-EP-K and should be fast enough to clamp fast transient overvoltage spikes. If by the choice of the TVS-diode or by the nature of the application transient overvoltage spikes > $V_{S(A7)}$ can be safely excluded the above mentioned blocking diode is sufficient for protecting the GND path. However, in cases where overvoltage spikes > $V_{S(AZ)}$ at VS still need to be considered a resistor in series to the diode needs to be placed in the GND path that limits the current through the GND path during such transient overvoltage events (see also Chapter 7.3.2). In such cases where a resistor in series to the external diode needs to be placed in the GND path also the resulting GND-shifts need to be considered. Especially when using the DC-pin to discharge the output after switch off events the resulting GND-shifts may become big for the duration $t_{\rm DC}$ of the discharge period. If the ITS6035S-EP-K is controlled with logic levels the resulting high ground shifts can mean that depending on load conditions the channel can only be switched on again after the discharge time t_{DC} has elapsed and the related GND shift has reached smaller values again. Therefore, when utilizing the DC-pin, it is recommended to cover transient overvoltage spikes by means of an external TVS-diode.

11.2.2 Input resistors for I/O pins

During fault conditions (e.g. reverse polarity, loss of GND, transient pulses at $V_{\rm S}$ or OUT, etc.) where the potential of I/O pins may become lower than the potential of device GND or where it may rise above the voltage being present at the VS-pin the ESD protection diodes of the corresponding I/O pins have to be protected by limiting the current through the pin by an external resistor. For the control pins IN and DEN a value of 10 k Ω for an input resistor will be fitting for a broad range of applications.

To use the status functionality, an external pull-up resistor needs to be placed at the ST-pin. This pull-up resistor must be dimensioned in a way that the ST-pin current during fault conditions is not exceeding the

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maximum ratings given in **Table 1** "**Absolute maximum ratings**" on **Page 8**. Therefore the dimensioning of the pull-up resistor will depend on whether it is connected to V_S or to the logic supply rail of the microcontroller. In addition, an input resistor R_{ST} to the microcontroller interface needs to be placed in the same manner and for the same reasons as mentioned above for the control pins IN and DEN.

Also the sense pin IS needs to be protected from both - reverse current flowing into the pin to VS (reverse polarity) as well as a current flowing from device GND via the ESD protection diode out of the pin if the device GND is shifted up to values higher than the potential at the IS-pin. The corresponding protection resistor $R_{\rm IS}$ needs to be chosen as well according to the specification of the microcontroller.

The OCT-pin will be protected by R_{OCT} in case of reverse polarity. This is also one reason that the OCT-pin must not be directly tied to device GND even if the highest possible current limitation threshold should be used. A corresponding fault flag will be set, if I_{OCT} exceeds the current threshold $I_{\text{OCT}(\text{short2GND})}^{1}$.

11.3 Current limitation adjustment

Table 14 below indicates which resistor value $R_{\rm OCT}$ needs to be soldered between OCT-pin and device GND to obtain a desired current limitation threshold $I_{\rm LIM(th,adj)}$. The adjusted current limitation threshold is defined for ambient temperature ($T_{\rm j}$ = 25°C) and hence, these values coincide with the typical values of the current limit at 25°C. **Table 14** provides an overview about the related minimum and maximum values of the current limit. In a separate column numbers for the maximum allowable $I_{\rm L(NOM)}$ also provides information about the required clearance distance of the output current to the adjusted current limit setting in order not to interact. This clearance needs to be respected for the nominal load current of a given application and represents an upper limit for the allowable nominal load current 2 . As the typical values of a selected current limit do not vary significantly from $T_{\rm j}$ = 25°C up to $T_{\rm j}$ = 150°C for most of the $I_{\rm OCT}$ - settings the given maximum and minimum values of the current limit listed in **Table 14** hold true for the temperature range 25°C $\leq T_{\rm j} \leq 150$ °C. Deviations that have to be expected for the typical values of the current limit at 150°C can be seen in **Figure 33**.

Figure 33 moreover illustrates how the current limitation values will shift for low temperatures. **Table 14** provides typical values for the current limitation for the extreme case of $T_j = -40$ °C. An overview of corresponding minimum and maximum values for the current limitation can be found here.

Using $R_{\rm OCT}$ resistor values $\leq 5~{\rm k}\Omega$ will always result in the current limitation value of the device which represents the maximum current limit value. In this way the application is still protected with the current limitation if the OCT-pin is accidently shorted to GND. Nevertheless $R_{\rm OCT} < 5.11~{\rm k}\Omega$ must not be used in applications as the susceptibility to EMC influences may increase. For the same reason the $R_{\rm OCT}$ resistor always has to be placed as close as possible to the OCT-pin and avoiding long traces with high inductances. Please note that for excessive $I_{\rm OCT}$ currents also a diagnosis flag will be set when reaching the corresponding threshold $I_{\rm OCT(short2GND)}^{3}$.

Using R_{OCT} values above 75 k Ω will bring the current limitation outside the allowed lower boundary of the current limit adjust range. It is not recommended to operate the device outside the allowed current limitation adjust range because the accuracy will decrease and stability of the regulation may suffer.

¹⁾ The corresponding flag is set in ON-state conditionally if DEN = low. See **Table 9 "Diagnostic truth table ST-pin" on Page 46** for further details

²⁾ Independent of this electrical restriction possibly additional restrictions due to thermal constraints may apply depending on the load current and thermal properties of the PCB

³⁾ This fault flag will be set only in ON-state and will depend on the logic state of the DEN-pin so that it can be distinguished from other fault situations by changing the logic state of DEN to high. For further information please refer to **Chapter 9.1**

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Table 14 R_{OCT} resistor value selection guide for adjusting current limitation threshold $I_{\text{LIM}(\text{th,adj})}$ and overview of resulting current limitation data (typical values & expected range) for temperature range 25°C ≤ T_i ≤ 150°C

$R_{\text{OCT}}[k\Omega]$	/ _{OCT} [μΑ]	$I_{LIM(th,adj)}$ [A] $(T_j = 25^{\circ}C)^{1}$	<i>I</i> _{LIM,MIN} [A] (25°C≤ <i>T</i> _j ≤150°C)	$I_{\text{LIM},MAX}$ [A] $(25^{\circ}\text{C} \le T_{j} \le 150^{\circ}\text{C})$	Typical of max allowable $I_{OUT}[A]^{2)}$	Comment
< 5.11 ³⁾	> 97.85	13.20	10.0	15.85	9.00	4)
5.11	97.85	13.20	10.0	15.85	9.00	5)
5.36	93.28	12.58	9.48	15.76	8.60	6)
5.62	88.97	12.00	8.99	15.67	8.22	6)
5.90	84.75	11.43	8.51	15.58	7.85	6)
6.19	80.78	10.90	8.06	15.50	7.50	5)
6.65	75.19	10.05	7.48	14.00	6.92	6)
7.15	69.93	9.26	6.93	12.58	6.37	6)
7.68	65.10	8.53	6.43	11.28	5.87	6)
8.25	60.61	7.85	5.96	10.06	5.40	5)
9.09	55.01	7.22	5.44	9.14	4.90	6)
10.0	50.00	6.65	4.97	8.32	4.45	7)
11.0	45.45	6.19	4.61	7.76	4.10	6)
12.1	41.23	5.77	4.29	7.24	3.77	6)
13.0	38.46	5.49	4.08	6.90	3.55	5)
15.0	33.33	5.07	3.70	6.41	3.18	6)
18.2	27.47	4.58	3.28	5.85	2.75	8)
21.5	23.26	4.25	3.02	5.45	2.46	6)
26.7	18.73	3.89	2.74	5.03	2.15	6)
33.2	15.06	3.60	2.51	4.68	1.90	5)
39.2	12.76	3.44	2.37	4.51	1.76	6)
56.2	8.90	3.17	2.14	4.22	1.52	6)
75.0	6.67	3.02	2.00	4.06	1.25	9)
> 75.0	< 6.67	-	-	-	-	outside specified range ¹⁰⁾

 $I_{\rm LIM(th,\,adj)}$ values coincide with typical values of the current limit $I_{\rm LIM}$ @ 25°C. Typical values for $I_{\rm LIM}$ @ 150°C may show deviation from $I_{LINM(th, adj)}$; see **Figure 33** for further details

²⁾ The listed values for I_{OUT} indicate the required clearance of the output current from the adjusted current limit without being at risk to interact. These values can be used as a maximum nominal current if there is no constraint from a thermal point of view

³⁾ R_{OCT} value must be selected in a way, that I_{OCT} current does not exceed $I_{\text{OCT(short2GND)}}$. Please be aware that if the OCTpin is connected with a too low R_{OCT} resistor to device GND the device will not be protected appropriately against reverse polarity. The device must not be operated with OCT-pin shorted to device GND

See also Electrical Characteristics: Protection Functions; Current limitation with setting I_{OCT} ≥ 97.85 μA (corresponds to $R_{OCT} \le 5.11 \text{ k}\Omega$)

35 m Ω single channel smart high-side power switch



Application information

- 5) Not subject to production test, values specified by design
- 6) Values given in this line are based on interpolation of corresponding neighboring specified values
- 7) See also Electrical Characteristics: Protection Functions; Current limitation with setting $I_{OCT} = 50 \mu A$ (corresponds to $R_{OCT} = 10 k\Omega$)
- 8) See also Electrical Characteristics: Protection Functions; Current limitation with setting I_{OCT} = 27.47 μ A (corresponds to R_{OCT} = 18.2 $k\Omega$)
- 9) See also Electrical Characteristics: Protection Functions; Current limitation with setting I_{OCT} = 6.67 μ A (corresponds to R_{OCT} = 75 $k\Omega$)
- 10) R_{OCT} values > 75k are not allowed for usage as the accuracy of the current limit will degrade

Table 15 R_{OCT} resistor value selection guide for adjusting current limitation threshold $I_{\text{LIM}(\text{th}, \text{adj})}$ and an overview of resulting current limitation data (typical values & expected range) for low temperatures $T_i = -40^{\circ}\text{C}$

$R_{\text{OCT}}[k\Omega]$	/ _{OCT} [μΑ]	$I_{\text{LIM,TYP}}$ [A] $(T_j = -40^{\circ}\text{C})$	$I_{\text{LIM,MIN}}$ [A] $(T_j = -40^\circ)$	I _{LIM,MAX} [A] (T _j =-40°C)	Typical of max allowable I_{OUT} [A] 1)	Comment
≤ 5.11 ²⁾	≥ 97.85	14.00	10.50	16.30	9.00	3)
5.11	97.85	14.00	10.50	16.30	9.00	4)
5.36	93.28	13.63	9.99	16.30	8.60	5)
5.62	88.97	13.28	9.51	16.30	8.22	5)
5.90	84.75	12.93	9.05	16.30	7.85	5)
6.19	80.78	12.60	8.60	16.30	7.50	4)
6.65	75.19	11.56	7.94	14.92	6.92	5)
7.15	69.93	10.58	7.32	13.62	6.37	5)
7.68	65.10	9.68	6.75	12.43	5.87	5)
8.25	60.61	8.85	6.22	11.32	5.40	4)
9.09	55.01	8.08	5.71	10.34	4.90	5)
10.0	50.00	7.40	5.25	9.47	4.45	6)
11.0	45.45	6.87	4.86	8.82	4.10	5)
12.1	41.23	6.37	4.50	8.22	3.77	5)
13.0	38.46	6.05	4.26	7.83	3.55	4)
15.0	33.33	5.56	3.82	7.24	3.18	5)
18.2	27.47	5.00	3.32	6.58	2.75	7)
21.5	23.26	4.58	2.98	6.11	2.46	5)
26.7	18.73	4.14	2.62	5.60	2.15	5)
33.2	15.06	3.77	2.33	5.20	1.90	4)
39.2	12.76	3.59	2.18	4.97	1.76	5)
56.2	8.90	3.27	1.92	4.59	1.52	5)
75.0	6.67	3.09	1.78	4.37	1.25	8)
> 75.0	< 6.67	-	-		-	outside specified range ⁹⁾

35 m Ω single channel smart high-side power switch



Application information

- 1) The listed values for I_{OUT} indicate the required clearance of the output current from the adjusted current limit without being at risk to interact. These values can be used as a maximum nominal current if there is no constraint from a thermal point of view
- 2) R_{OCT} value must be selected in a way, that I_{OCT} current does not exceed $I_{\text{OCT}(\text{short2GND})}$. Please be aware that if the OCT-pin is connected with an too low R_{OCT} resistor to device GND the device will not be protected appropriately against reverse polarity. The device must not be operated with OCT-pin shorted to device GND
- 3) See also Electrical Characteristics: Protection Functions; Current limitation with setting $I_{OCT} \ge 97.85 \mu A$ (corresponds to $R_{OCT} \le 5.11 k\Omega$)
- 4) Not subject to production test, values specified by design
- 5) Values given in this line are based on interpolation of corresponding neighboring specified values
- 6) See also Electrical Characteristics: Protection Functions; Current limitation with setting $I_{OCT} = 50 \mu A$ (corresponds to $R_{OCT} = 10 kΩ$)
- 7) See also Electrical Characteristics: Protection Functions; Current limitation with setting $I_{OCT} = 27.47 \mu A$ (corresponds to $R_{OCT} = 18.2 k\Omega$)
- 8) See also Electrical Characteristics: Protection Functions; Current limitation with setting I_{OCT} = 6.67 μA (corresponds to R_{OCT} = 75 kΩ)
- 9) R_{OCT} values > 75k are not recommended for usage as the accuracy of the current limit will degrade

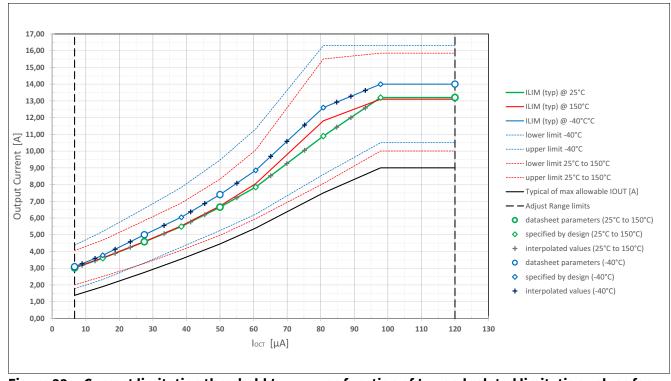


Figure 33 Current limitation threshold $I_{\text{LIM}(\text{th,adj})}$ as function of I_{OCT} and related limitation values for different temperatures.



Package outlines

12 Package outlines

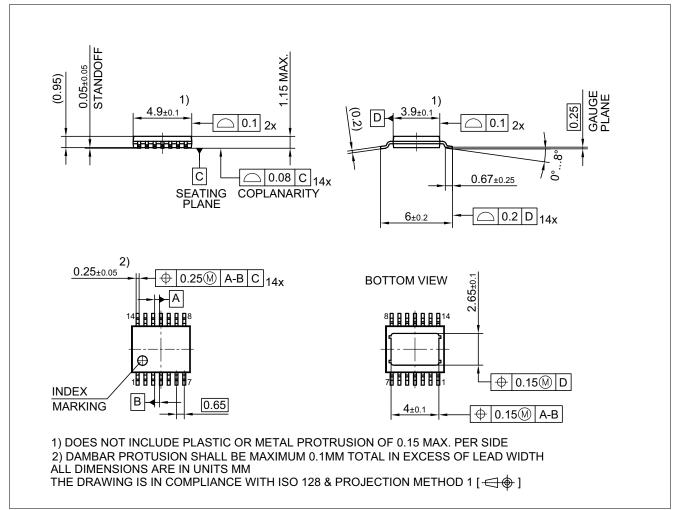


Figure 34 PG-TSDSO-14 (Plastic Dual Small Outline Package) (RoHS-Compliant)

Green Product (RoHS compliant)

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e. Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020).

$35\ m\Omega$ single channel smart high-side power switch



Revision history

Revision history 13

Revision	Date	Changes	
1.00	2023-07-27	Initial datasheet release	

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